

# LMX2430, LMX2433, LMX2434

*LMX2430/LMX2433/LMX2434 PLLatinum Dual High Frequency Synthesizer for RF  
Personal Communications*  
LMX2430 3.0 GHz/0.8 GHz  
LMX2433 3.6 GHz/1.7  
GHz  
LMX2434 5.0 GHz/2.5 GHz



Literature Number: SNAS187B

# LMX2430/LMX2433/LMX2434 PLLatinum™ Dual High Frequency Synthesizer for RF Personal Communications

**LMX2430 3.0 GHz/0.8 GHz**  
**LMX2433 3.6 GHz/1.7 GHz**  
**LMX2434 5.0 GHz/2.5 GHz**

## General Description

The LMX243x devices are high performance frequency synthesizers with integrated dual modulus prescalers. The LMX243x devices are designed for use as RF and IF local oscillators for dual conversion radio transceivers.

A 32/33 or a 16/17 prescale ratio can be selected for the 5.0 GHz LMX2434 RF synthesizer. An 8/9 or a 16/17 prescale ratio can be selected for both the LMX2430 and LMX2433 RF synthesizers. The IF circuitry contains an 8/9 or a 16/17 prescaler. Using a proprietary digital phase locked loop technique, the LMX243x devices generate very stable, low noise control signals for RF and IF voltage controlled oscillators. Both the RF and IF synthesizers include a two-level programmable charge pump. Both the RF and IF synthesizers have dedicated Fastlock circuitry with integrated timeout counters. Furthermore, only a single word write is required to power up and tune the synthesizers to a new frequency.

Serial data is transferred to the devices via a three-wire interface (DATA, LE, CLK). A low voltage logic interface allows direct connection to 1.8V devices. Supply voltages from 2.25V to 2.75V are supported. The LMX243x family features low current consumption:

LMX2430 (3.0 GHz/ 0.8 GHz)—2.8 mA/ 1.4 mA, LMX2433 (3.6 GHz/ 1.7 GHz) —3.2 mA/ 2.0 mA, LMX2434 (5.0 GHz/ 2.5 GHz)—4.6 mA/ 2.4 mA at 2.50V.

The LMX243x devices are available in 20-Pin TSSOP and 20-Pin UTCSP surface mount plastic packages.

## Features

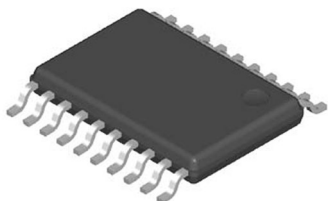
- Low Current Consumption
- 2.25V to 2.75V Operation
- Selectable Synchronous or Asynchronous Powerdown Mode
- Selectable Dual Modulus Prescaler:
 

LMX2430	RF: 8/9 or 16/17
LMX2433	RF: 8/9 or 16/17
LMX2434	RF: 16/17 or 32/33
LMX243x	IF: 8/9 or 16/17
- Programmable Charge Pump Current Levels  
RF and IF: 1 or 4 mA
- Fastlock™ Technology with Integrated Timeout Counters
- Digital Filtered Lock Detect Output
- Analog Lock Detect Output (supports both Push-Pull and Open Drain configurations)
- 1.8V MICROWIRE Logic Interface
- Available in 20-Pin TSSOP and 20-Pin UTCSP

## Applications

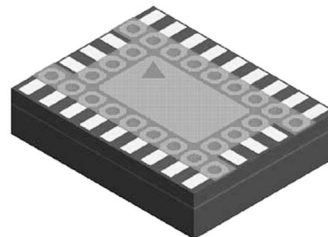
- Mobile Handsets  
(GSM, GPRS, W-CDMA, CDMA, PCS, AMPS, PDC, DCS)
- Cordless Handsets  
(DECT, DCT)
- Wireless Data
- Cable TV Tuners

Thin Shrink Small Outline Package (MTC20)



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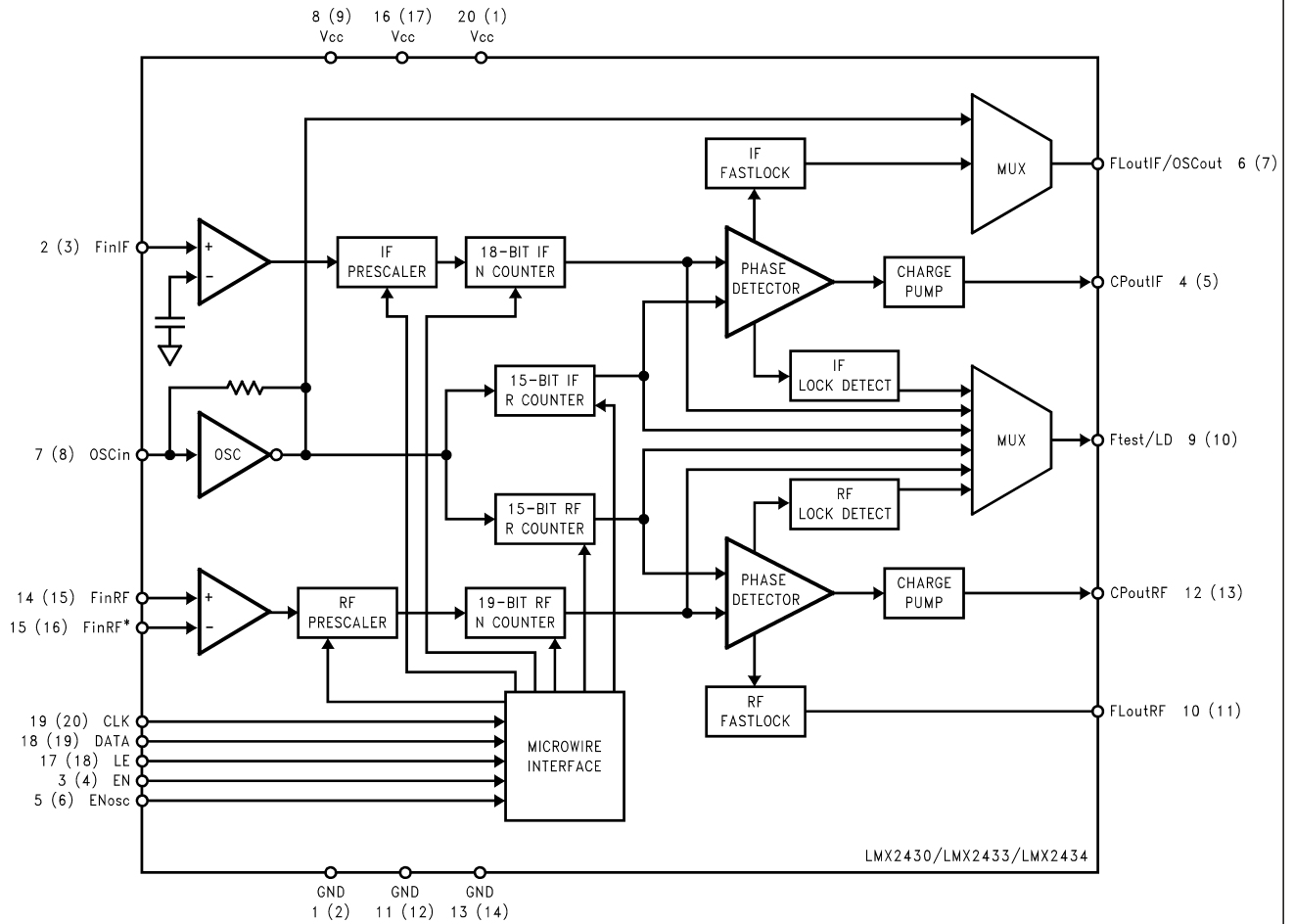
Ultra Thin Chip Scale Package (SLE20A)



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## Functional Block Diagram



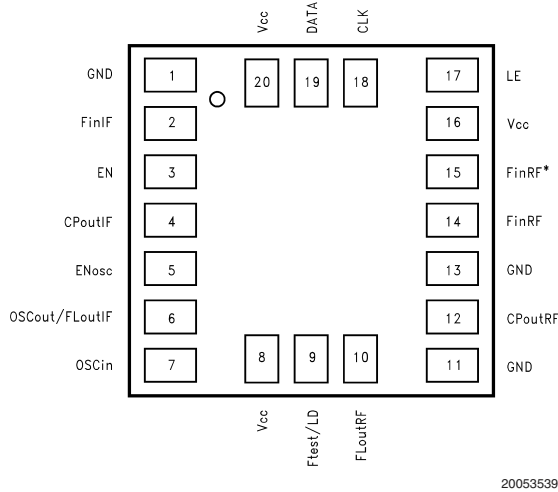
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**Note:**

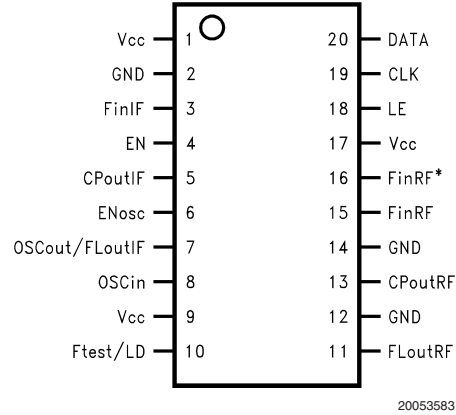
1 (2) refers to Pin #1 of the 20-Pin UTCSP and Pin #2 of the 20-Pin TSSOP

## Connection Diagrams

**Ultra Thin Chip Scale Package (SLE)  
(Top View)**



**Thin Shrink Small Outline Package (TM)  
(Top View)**



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## Pin Descriptions

Pin No. UTCSP	Pin No. TSSOP	Pin Name	I/O	Description
1	2	GND	—	Ground for the IF PLL analog and digital circuits, MICROWIRE™, Ftest/LD and oscillator circuits.
2	3	FinIF	I	IF PLL prescaler input. Small signal input from the VCO.
3	4	EN	I	Chip Enable input. High Impedance CMOS input. When this pin is set HIGH, the RF and IF PLLs are powered up. Powerdown is then controlled through the MICROWIRE. When this pin is set LOW, the device is asynchronously powered down and the charge pump output is forced to a high impedance state (TRI-STATE).
4	5	CPoutIF	O	IF PLL charge pump output. The output is connected to the external loop filter, which drives the input of the IF VCO.
5	6	ENosc	I	Oscillator Enable input. High impedance CMOS input. When this pin is set HIGH, the oscillator buffer is always powered up, independent of the state of the EN pin. When this pin is set LOW, the OSCout/ FLoutIF pin functions as an IF Fastlock output, which connects a resistor in parallel to R2 of the external loop filter.
6	7	OSCout/ FLoutIF	O	Oscillator output/ IF PLL Fastlock output. The output configuration is dependent on the state of the ENosc pin. When ENosc is set LOW, the pin functions as an IF Fastlock output, which connects a resistor in parallel to R2 of the external loop filter. This configuration also functions as a general purpose CMOS TRI-STATE output. When ENosc is set HIGH, the pin functions as an oscillator output so that an external crystal can be used.
7	8	OSCin	I	Reference oscillator input. The input has an approximate Vcc/2 threshold and is driven by an external AC coupled source.
8	9	Vcc	—	Power supply bias for the RF PLL digital circuits and oscillator circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.
9	10	Ftest/LD	O	Programmable multiplexed output. Functions as a general purpose CMOS TRI-STATE output, N and R divider output, RF/ IF PLL push-pull analog lock detect output, RF/ IF PLL open-drain analog lock detect output, or RF/ IF PLL digital filtered lock detect output.

## Pin Descriptions (Continued)

Pin No. UTCSP	Pin No. TSSOP	Pin Name	I/O	Description
10	11	FLoutRF	O	RF PLL Fastlock output. This pin connects a resistor in parallel to R2 of the external loop filter. This pin can also function as a general purpose CMOS TRI-STATE output.
11	12	GND	—	Ground for the RF PLL digital circuits.
12	13	CPoutRF	O	RF PLL charge pump output. The output is connected to the external loop filter, which drives the input of the RF VCO.
13	14	GND	—	Ground for the RF PLL analog circuits.
14	15	FinRF	I	RF PLL prescaler input. Small signal input from the VCO.
15	16	FinRF*	I	RF PLL prescaler complementary input. For single ended operation, this pin should be AC grounded through a 100 pF capacitor. The LMX243x can be driven differentially when the AC coupled capacitor is omitted.
16	17	Vcc	—	Power supply bias for the RF PLL analog circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.
17	18	LE	I	MICROWIRE Latch Enable input. High impedance CMOS input. When LE transitions HIGH, DATA stored in the shift register is loaded into one of 6 internal control registers.
18	19	CLK	I	MICROWIRE Clock input. High impedance CMOS input. DATA is clocked into the 24-bit shift register on the rising edge of CLK.
19	20	DATA	I	MICROWIRE Data input. High impedance CMOS input. Binary serial data. The MSB of DATA is shifted in first. The two last bits are the control bits.
20	1	Vcc	—	Power supply bias for the IF PLL analog and digital circuits, MICROWIRE, and Ftest/LD circuits. Vcc may range from 2.25V to 2.75V. Bypass capacitors should be placed as close as possible to this pin and be connected directly to the ground plane.

## Ordering Information

Model	Temperature Range	Package Description	Packing	NS Package Number
LMX2430TM	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP)	73 Units Per Rail	MTC20
LMX2430TMX	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP) Tape and Reel	2500 Units Per Reel	MTC20
LMX2430SLEX	-40°C to +85°C	Ultra Thin Chip Scale Package (UTCSP) Tape and Reel	2500 Units Per Reel	SLE20A
LMX2433TM	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP)	73 Units Per Rail	MTC20
LMX2433TMX	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP) Tape and Reel	2500 Units Per Reel	MTC20
LMX2433SLEX	-40°C to +85°C	Ultra Thin Chip Scale Package (UTCSP) Tape and Reel	2500 Units Per Reel	SLE20A
LMX2434TM	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP)	73 Units Per Rail	MTC20
LMX2434TMX	-40°C to +85°C	Thin Shrink Small Outline Package (TSSOP) Tape and Reel	2500 Units Per Reel	MTC20
LMX2434SLEX	-40°C to +85°C	Ultra Thin Chip Scale Package (UTCSP) Tape and Reel	2500 Units Per Reel	SLE20A

**Absolute Maximum Ratings** (Notes 1,

2, 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Power Supply Voltage

V<sub>CC</sub> to GND -0.3V to +3.25VVoltage on any pin to GND (V<sub>I</sub>)V<sub>I</sub> must be < +3.25V -0.3V to V<sub>CC</sub>+0.3VStorage Temperature Range (T<sub>S</sub>) -65°C to +150°CLead Temperature (solder 4 s) (T<sub>L</sub>) +260°C**Recommended Operating Conditions** (Note 1)

Power Supply Voltage

V<sub>CC</sub> to GND +2.25V to +2.75VOperating Temperature (T<sub>A</sub>) -40°C to +85°C

**Note 1:** Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Recommended Operating Conditions indicate conditions for which the device is intended to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, refer to the Electrical Characteristics section. The guaranteed specifications apply only for the conditions listed.

**Note 2:** This device is a high performance RF integrated circuit with an ESD rating <2 kV and is ESD sensitive. Handling and assembly of this device should only be done at ESD protected work stations.

**Note 3:** GND = 0V

**Electrical Characteristics**V<sub>CC</sub> = EN = 2.5V, -40°C ≤ T<sub>A</sub> ≤ +85°C, unless otherwise specified

Symbol	Parameter	Conditions	Value			Units	
			Min	Typ	Max		
<b>I<sub>CC</sub> PARAMETERS</b>							
I <sub>CCRF</sub>	Power Supply Current, RF Synthesizer	LMX2430	CLK, DATA and LE = 0V OSCI <sub>n</sub> = GND		2.8	3.6	mA
		LMX2433	RF_PD Bit = 0		3.2	4.4	mA
		LMX2434	IF_PD Bit = 1 RF_P Bit = 0		4.6	6.2	mA
I <sub>CCIF</sub>	Power Supply Current, IF Synthesizer	LMX2430	CLK, DATA and LE = 0V OSCI <sub>n</sub> = GND		1.4	2.0	mA
		LMX2433	RF_PD Bit = 1		2.0	2.8	mA
		LMX2434	IF_PD Bit = 0 IF_P Bit = 0		2.4	3.5	mA
I <sub>CCPD</sub>	Powerdown Current		EN, ENosc, CLK, DATA and LE = 0V			10	μA
<b>RF SYNTHESIZER PARAMETERS</b>							
f <sub>FinRF</sub>	RF Operating Frequency	LMX2430	RF_P Bit = 0	250		2500	MHz
			RF_P Bit = 1	250		3000	MHz
		LMX2433	RF_P Bit = 0	500		3000	MHz
			RF_P Bit = 1	500		3600	MHz
LMX2434	RF_P Bit = 0 or 1	1000		5000	MHz		
N <sub>RF</sub>	N Divider Range		P = 8/9 (Note 4)	24		262151	
			P = 16/17 (Note 4)	48		524287	
			P = 32/33 (Note 4)	96		524287	
R <sub>RF</sub>	RF R Divider Range			3		32767	
f <sub>COMPRF</sub>	RF Phase Detector Frequency					10	MHz
P <sub>FinRF</sub>	RF Input Sensitivity	LMX2430/33	2.25V ≤ V <sub>CC</sub> ≤ 2.75V (Note 5)	-15		0	dBm
		LMX2434	2.35V ≤ V <sub>CC</sub> ≤ 2.75V (Note 5)	-12		0	dBm

**Electrical Characteristics** (Continued)V<sub>CC</sub> = EN = 2.5V, -40°C ≤ T<sub>A</sub> ≤ +85°C, unless otherwise specified

Symbol	Parameter	Conditions	Value			Units	
			Min	Typ	Max		
<b>RF SYNTHESIZER PARAMETERS</b>							
I <sub>CPoutRF</sub> Source	RF Charge Pump Output Source Current	V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 RF_CPG Bit = 0 (Note 6)		-1.0		mA	
		V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 RF_CPG Bit = 1 (Note 6)		-4.0		mA	
I <sub>CPoutRF</sub> Sink	RF Charge Pump Output Sink Current	V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 RF_CPG Bit = 0 (Note 6)		1.0		mA	
		V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 RF_CPG Bit = 1 (Note 6)		4.0		mA	
I <sub>CPoutRF</sub> TRI	RF Charge Pump Output TRI-STATE Current	0.5V ≤ V <sub>CPoutRF</sub> ≤ V <sub>CC</sub> - 0.5V (Note 6)	-2.5		2.5	nA	
I <sub>CPoutRF</sub> %MIS	RF Charge Pump Output Sink Current Vs Charge Pump Output Source Current Mismatch	V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 (Note 7)		3	10	%	
I <sub>CPoutRF</sub> %V <sub>CPoutRF</sub>	RF Charge Pump Output Current Magnitude Variation Vs Charge Pump Output Voltage	0.5V ≤ V <sub>CPoutRF</sub> ≤ V <sub>CC</sub> - 0.5V (Note 7)		5	15	%	
I <sub>CPoutRF</sub> %T <sub>A</sub>	RF Charge Pump Output Current Magnitude Variation Vs Temperature	V <sub>CPoutRF</sub> = V <sub>CC</sub> /2 (Note 7)		2		%	
<b>IF SYNTHESIZER PARAMETERS</b>							
f <sub>FinIF</sub>	IF Operating Frequency	LMX2430	IF_P Bit = 0 or 1	100		800	MHz
		LMX2433	IF_P Bit = 0 or 1	250		1700	MHz
		LMX2434	IF_P Bit = 0 or 1	500		2500	MHz
N <sub>IF</sub>	IF N Divider Range	P = 8/9 (Note 4)		24		131079	
		P = 16/17 (Note 4)		48		262143	
R <sub>IF</sub>	IF R Divider Range			3		32767	
f <sub>COMPif</sub>	IF Phase Detector Frequency					10	MHz
P <sub>FinIF</sub>	IF Input Sensitivity	2.25V ≤ V <sub>CC</sub> ≤ 2.75V (Note 5)		-15		0	dBm
I <sub>CPoutIF</sub> Source	IF Charge Pump Output Source Current	V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 IF_CPG Bit = 0 (Note 6)		-1.0		mA	
		V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 IF_CPG Bit = 1 (Note 6)		-4.0		mA	
I <sub>CPoutIF</sub> Sink	IF Charge Pump Output Sink Current	V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 IF_CPG Bit = 0 (Note 6)		1.0		mA	
		V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 IF_CPG Bit = 1 (Note 6)		4.0		mA	

**Electrical Characteristics** (Continued)V<sub>CC</sub> = EN = 2.5V, -40°C ≤ T<sub>A</sub> ≤ +85°C, unless otherwise specified

Symbol	Parameter	Conditions	Value			Units
			Min	Typ	Max	
<b>IF SYNTHESIZER PARAMETERS</b>						
I <sub>CPoutIF</sub> TRI	IF Charge Pump Output TRI-STATE Current	0.5V ≤ V <sub>CPoutIF</sub> ≤ V <sub>CC</sub> - 0.5V (Note 6)	-2.5		2.5	nA
I <sub>CPoutIF</sub> %MIS	IF Charge Pump Output Sink Current Vs Charge Pump Output Source Current Mismatch	V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 (Note 7)		3	10	%
I <sub>CPoutIF</sub> %V <sub>CPoutIF</sub>	IF Charge Pump Output Current Magnitude Variation Vs Charge Pump Output Voltage	0.5V ≤ V <sub>CPoutIF</sub> ≤ V <sub>CC</sub> - 0.5V (Note 7)		5	15	%
I <sub>CPoutIF</sub> %T <sub>A</sub>	IF Charge Pump Output Current Magnitude Variation Vs Temperature	V <sub>CPoutIF</sub> = V <sub>CC</sub> /2 (Note 7)		2		%
<b>OSCILLATOR PARAMETERS</b>						
f <sub>OSCin</sub>	Oscillator Operating Frequency		1		256	MHz
V <sub>OSCin</sub>	Oscillator Sensitivity	(Note 8)	0.5		V <sub>CC</sub>	V <sub>PP</sub>
I <sub>OSCin</sub>	Oscillator Input Current	V <sub>OSCin</sub> = V <sub>CC</sub>			100	μA
		V <sub>OSCin</sub> = 0V	-100			μA
<b>DIGITAL INTERFACE (DATA, CLK, LE, EN, ENosc, Ftest/LD, FLoutRF, OSCout/ FLoutIF)</b>						
V <sub>IH</sub>	High-Level Input Voltage		1.6			V
V <sub>IL</sub>	Low-Level Input Voltage				0.4	V
I <sub>IH</sub>	High-Level Input Current	V <sub>IH</sub> = V <sub>CC</sub>			1.0	μA
I <sub>IL</sub>	Low-Level Input Current	V <sub>IL</sub> = 0V	-1.0			μA
V <sub>OH</sub>	High-Level Output Voltage	I <sub>OH</sub> = -500 μA	V <sub>CC</sub> - 0.4			V
V <sub>OL</sub>	Low-Level Output Voltage	I <sub>OL</sub> = 500 μA			0.4	V
<b>MICROWIRE INTERFACE</b>						
t <sub>CS</sub>	DATA to CLK Set Up Time	(Note 9)	50			ns
t <sub>CH</sub>	DATA to CLK Hold Time	(Note 9)	10			ns
t <sub>CWH</sub>	CLK Pulse Width HIGH	(Note 9)	50			ns
t <sub>CWL</sub>	CLK Pulse Width LOW	(Note 9)	50			ns
t <sub>ES</sub>	CLK to LE Set Up Time	(Note 9)	50			ns
t <sub>EW</sub>	LE Pulse Width	(Note 9)	50			ns

## Electrical Characteristics (Continued)

V<sub>CC</sub> = EN = 2.5V, -40°C ≤ T<sub>A</sub> ≤ +85°C, unless otherwise specified

Symbol	Parameter	Conditions	Value			Units	
			Min	Typ	Max		
<b>PHASE NOISE CHARACTERISTICS</b>							
L <sub>NRF</sub> (f)	RF Synthesizer Normalized Phase Noise Contribution (Note 10)	TCXO Reference Source RF_CPG Bit = 1 IF_PD Bit = 1		-219.0		dBc/ Hz	
L <sub>NIF</sub> (f)	IF Synthesizer Normalized Phase Noise Contribution (Note 10)	TCXO Reference Source IF_CPG Bit = 1 RF_PD Bit = 1		-214.0		dBc/ Hz	
L <sub>RF</sub> (f)	RF Synthesizer Single Side Band Phase Noise Measured	LMX2430	f <sub>FinRF</sub> = 2750 MHz f = 10 kHz offset f <sub>COMP<sub>RF</sub></sub> = 1 MHz Loop Bandwidth = 100 kHz N <sub>RF</sub> = 2750 f <sub>OSCin</sub> = 10 MHz V <sub>OSCin</sub> = 1 V <sub>PP</sub> RF_CPG Bit = 1 IF_PD Bit = 1 T <sub>A</sub> = +25°C (Note 11)		-90.30		dBc/ Hz
		LMX2433	f <sub>FinRF</sub> = 3200 MHz f = 10 kHz offset f <sub>COMP<sub>RF</sub></sub> = 1 MHz Loop Bandwidth = 100 kHz N <sub>RF</sub> = 3200 f <sub>OSCin</sub> = 10 MHz V <sub>OSCin</sub> = 1 V <sub>PP</sub> RF_CPG Bit = 1 IF_PD Bit = 1 T <sub>A</sub> = +25°C (Note 11)		-88.90		dBc/ Hz
		LMX2434	f <sub>FinRF</sub> = 4700 MHz f = 10 kHz offset f <sub>COMP<sub>RF</sub></sub> = 1 MHz Loop Bandwidth = 100 kHz N <sub>RF</sub> = 4700 f <sub>OSCin</sub> = 10 MHz V <sub>OSCin</sub> = 1 V <sub>PP</sub> RF_CPG Bit = 1 IF_PD Bit = 1 T <sub>A</sub> = +25°C (Note 11)		-85.60		dBc/ Hz

**Note 4:** Some of the values in this range are illegal divide ratios (B < A). To obtain continuous legal division, the Minimum Divide Ratio must be calculated. Use N ≥ P \* (P-1), where P is the value of the prescaler selected.

**Note 5:** Refer to the LMX243x FinRF Sensitivity Test Setup section

**Note 6:** Refer to the LMX243x Charge Pump Test Setup section

**Note 7:** Refer to the Charge Pump Current Specification Definitions for details on how these measurements are made.

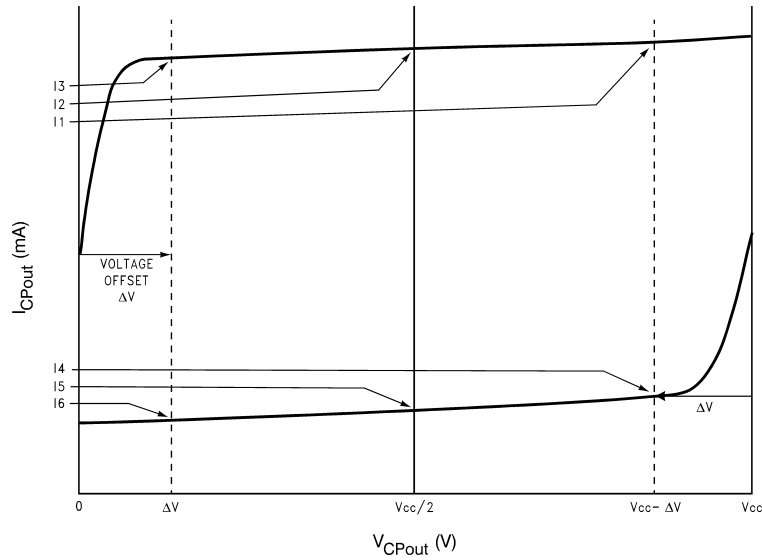
**Note 8:** Refer to the LMX243x OSCin Sensitivity Test Setup section

**Note 9:** Refer to the LMX243x Serial Data Input Timing section

**Note 10:** Normalized Phase Noise Contribution is defined as: L<sub>N</sub>(f) = L(f) - 20 log(N) - 10 log(f<sub>COMP</sub>), where L(f) is defined as the single side band phase noise measured at an offset frequency, f, in a 1 Hz bandwidth. The offset frequency, f, must be chosen sufficiently smaller than the PLL's loop bandwidth, yet large enough to avoid substantial phase noise contribution from the reference source. N is the value selected for the feedback divider and f<sub>COMP</sub> is the RF/IF phase/ frequency detector comparison frequency.

**Note 11:** The synthesizer phase noise is measured with the LMX2430TM/LMX2430SLE Evaluation boards and the HP8566B Spectrum Analyzer.

## Charge Pump Current Specification Definitions



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I1 = Charge Pump Sink Current at  $V_{CPout} = V_{cc} - \Delta V$

I2 = Charge Pump Sink Current at  $V_{CPout} = V_{cc}/2$

I3 = Charge Pump Sink Current at  $V_{CPout} = \Delta V$

I4 = Charge Pump Source Current at  $V_{CPout} = V_{cc} - \Delta V$

I5 = Charge Pump Source Current at  $V_{CPout} = V_{cc}/2$

I6 = Charge Pump Source Current at  $V_{CPout} = \Delta V$

$\Delta V$  = Voltage offset from the positive and negative rails. Dependent on the VCO tuning range relative to  $V_{cc}$  and GND. Typical values are between 0.5V and 1.0V.

$V_{CPout}$  refers to either  $V_{CPoutRF}$  or  $V_{CPoutIF}$

$I_{CPout}$  refers to either  $I_{CPoutRF}$  or  $I_{CPoutIF}$

### Charge Pump Output Current Magnitude Variation Vs Charge Pump Output Voltage

$$I_{CPout} \text{ Vs } V_{CPout} = \frac{(|I1| - |I3|)}{(|I1| + |I3|)} \times 100\%$$

$$= \frac{(|I4| - |I6|)}{(|I4| + |I6|)} \times 100\%$$

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### Charge Pump Output Sink Current Vs Charge Pump Output Source Current Mismatch

$$I_{CPout} \text{ Sink Vs } I_{CPout} \text{ Source} = \frac{|I2| - |I5|}{\frac{1}{2}(|I2| + |I5|)} \times 100\%$$

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### Charge Pump Output Current Magnitude Variation Vs Temperature

$$I_{CPout} \text{ Vs } T_A = \frac{|I2|_{T_A} - |I2|_{T_A=25^\circ C}}{|I2|_{T_A=25^\circ C}} \times 100\%$$

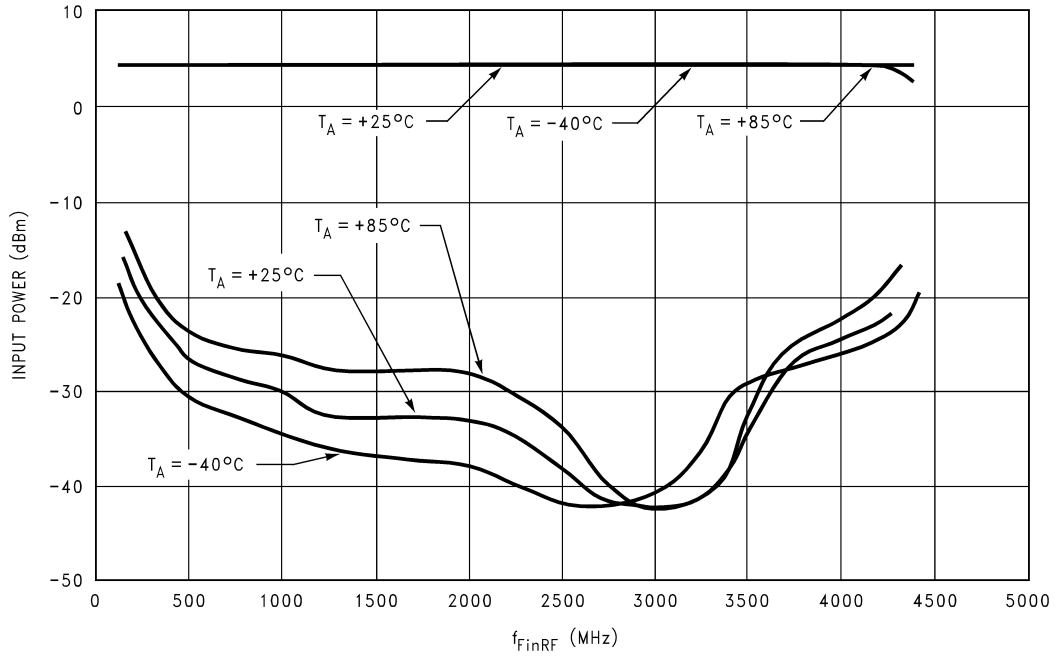
$$= \frac{|I5|_{T_A} - |I5|_{T_A=25^\circ C}}{|I5|_{T_A=25^\circ C}} \times 100\%$$

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# Typical Performance Characteristics

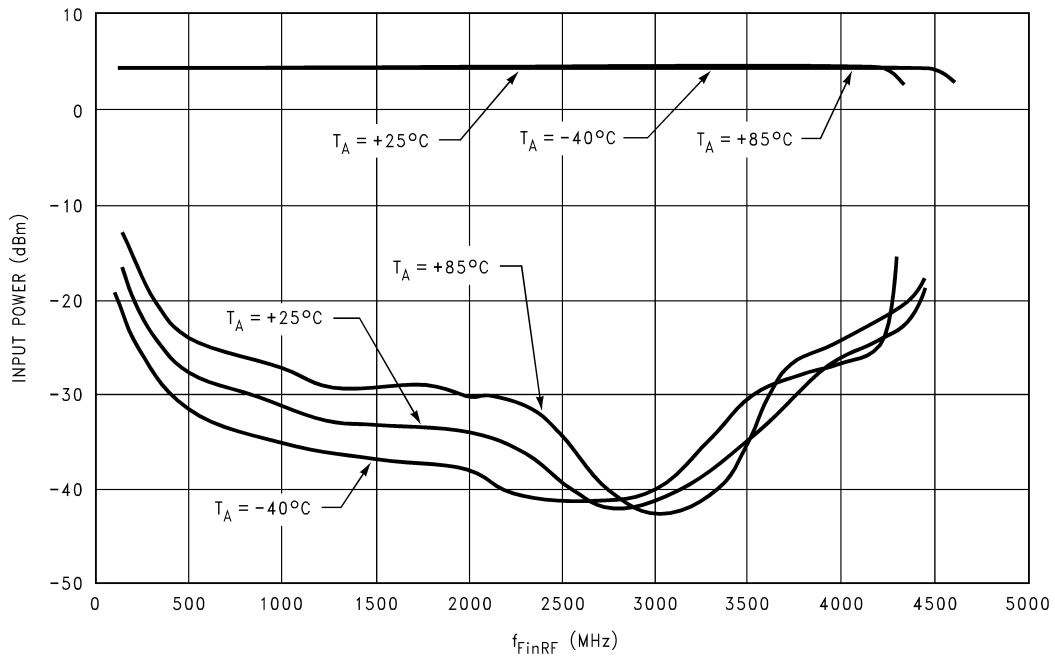
## Sensitivity

LMX2430 FinRF Input Power Vs Frequency  
 $V_{CC} = EN = 2.25V$



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LMX2430 FinRF Input Power Vs Frequency  
 $V_{CC} = EN = 2.75V$

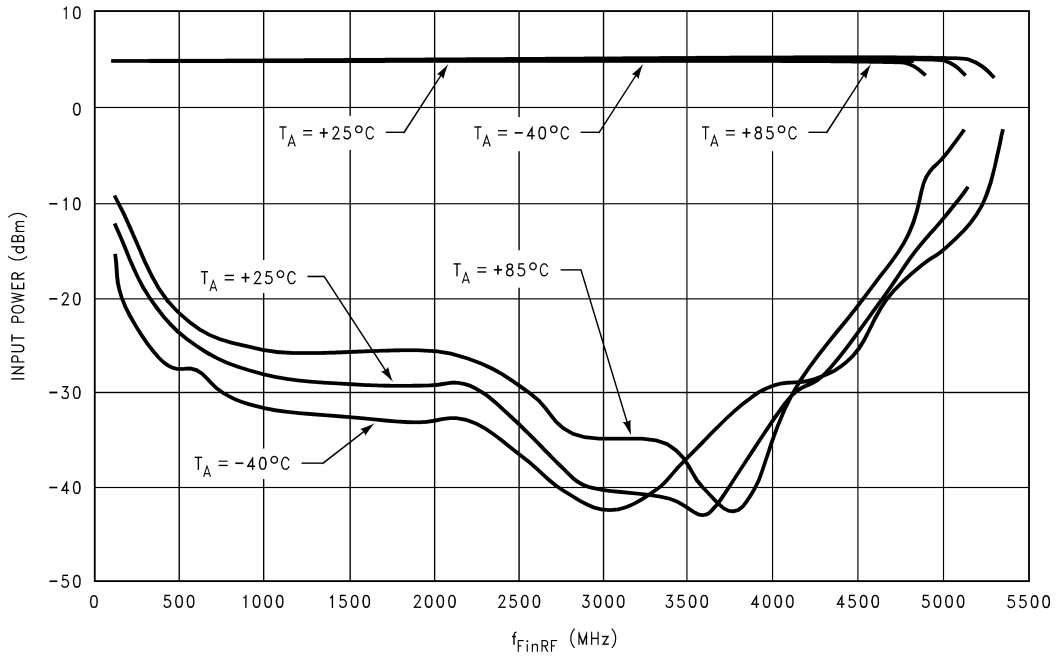


20053593

# Typical Performance Characteristics

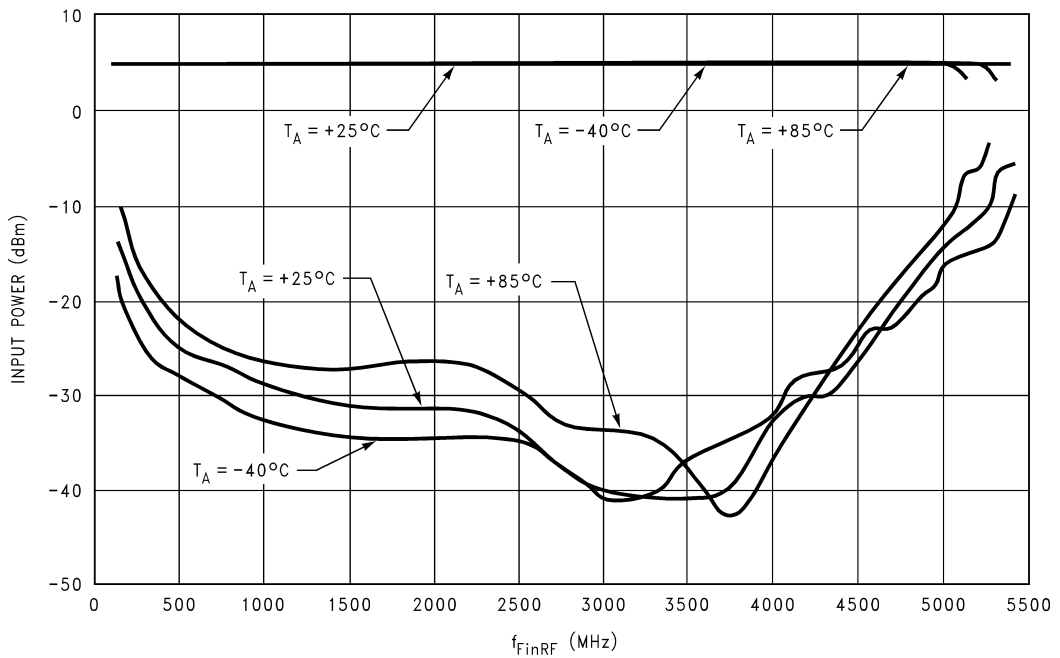
## Sensitivity (Continued)

**LMX2433 FinRF Input Power Vs Frequency**  
**V<sub>cc</sub> = EN = 2.25V**



20053594

**LMX2433 FinRF Input Power Vs Frequency**  
**V<sub>cc</sub> = EN = 2.75V**

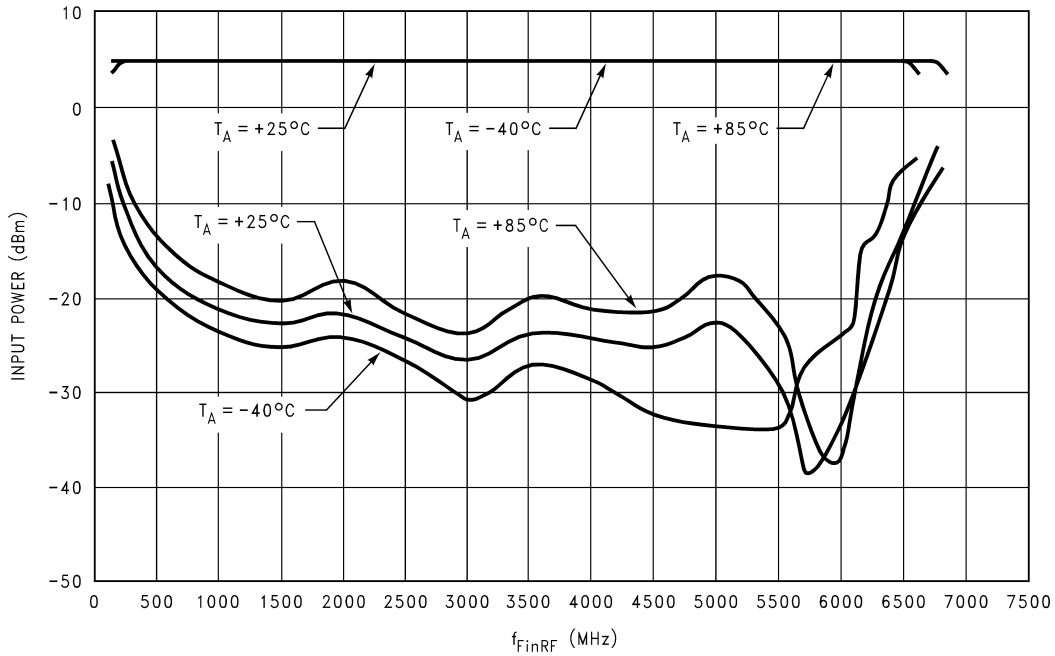


20053595

# Typical Performance Characteristics

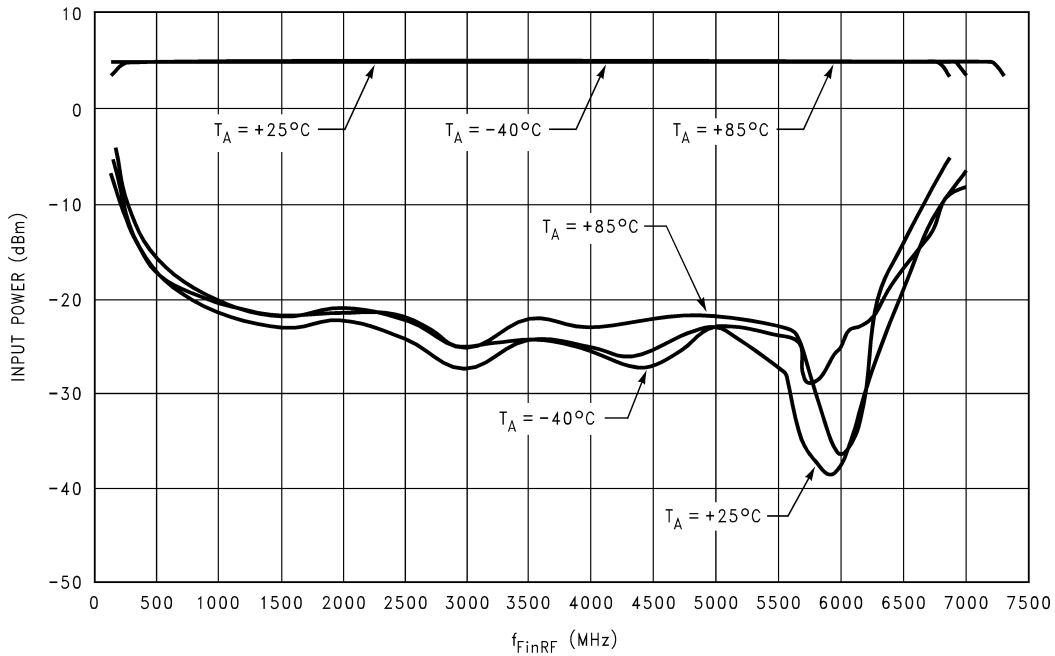
## Sensitivity (Continued)

**LMX2434 FinRF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.35V**



20053596

**LMX2434 FinRF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.75V**

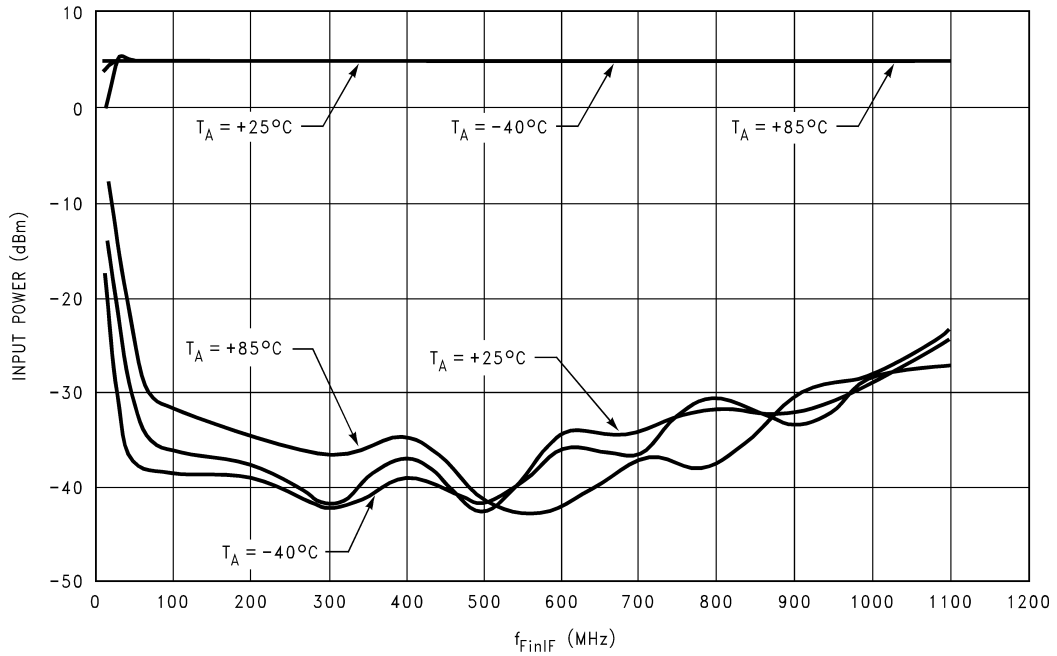


20053597

# Typical Performance Characteristics

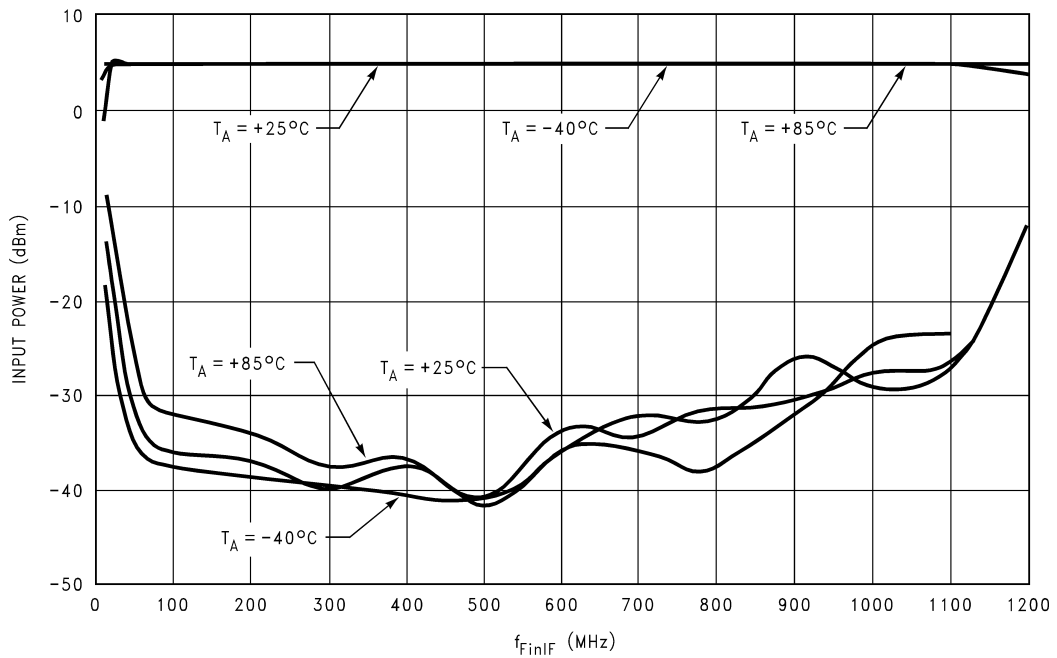
## Sensitivity (Continued)

LMX2430 FinIF Input Power Vs Frequency  
 $V_{CC} = EN = 2.25V$



20053598

LMX2430 FinIF Input Power Vs Frequency  
 $V_{CC} = EN = 2.75V$

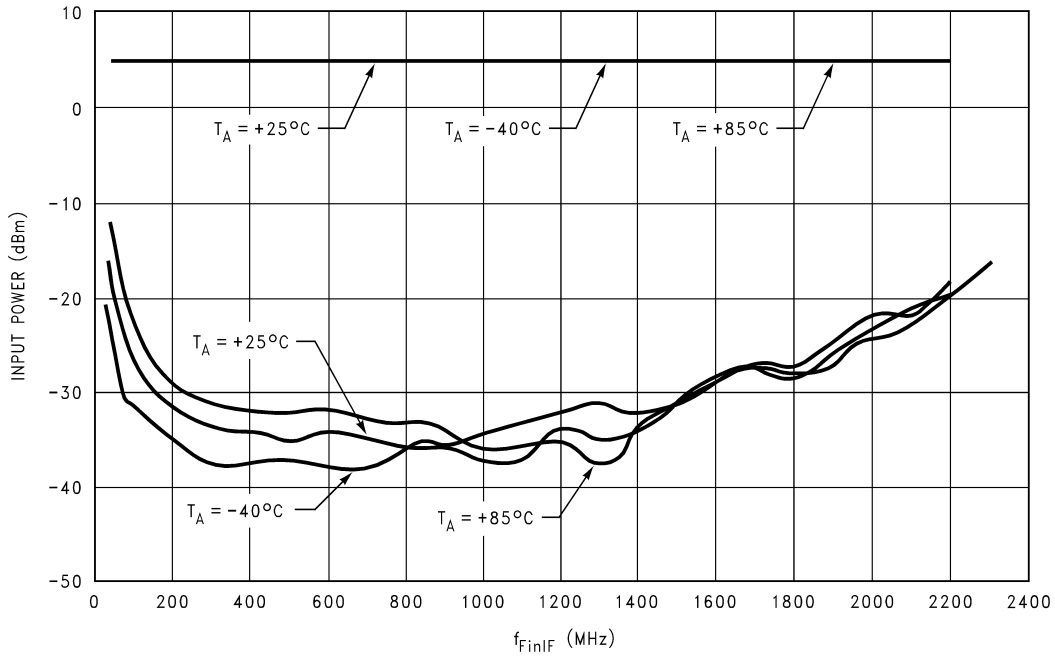


20053599

# Typical Performance Characteristics

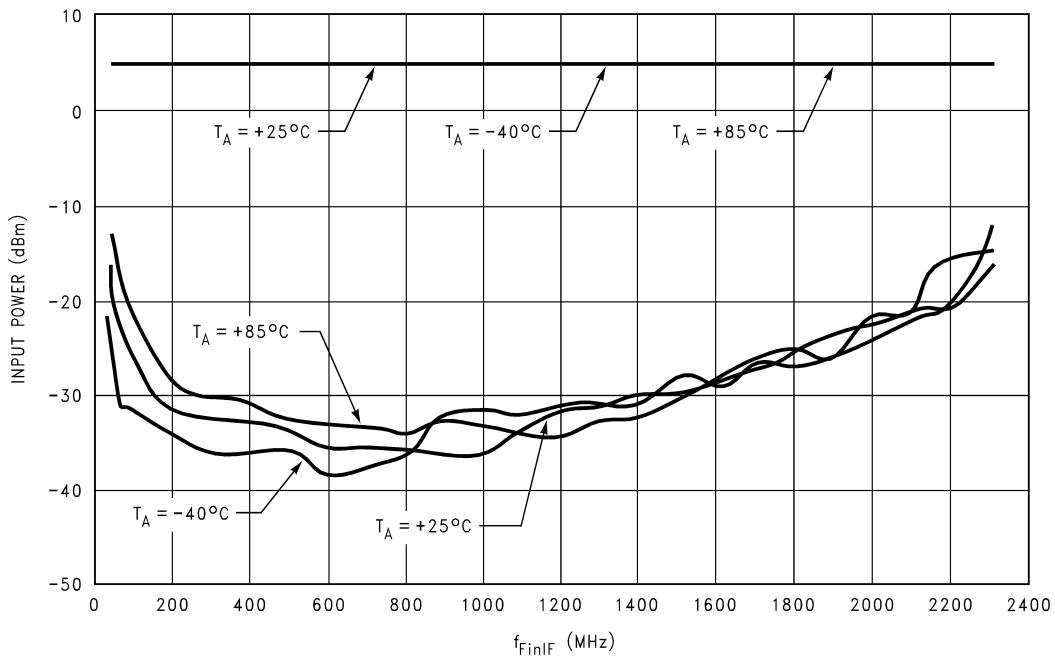
## Sensitivity (Continued)

**LMX2433 FinIF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.25V**



200535A0

**LMX2433 FinIF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.75V**

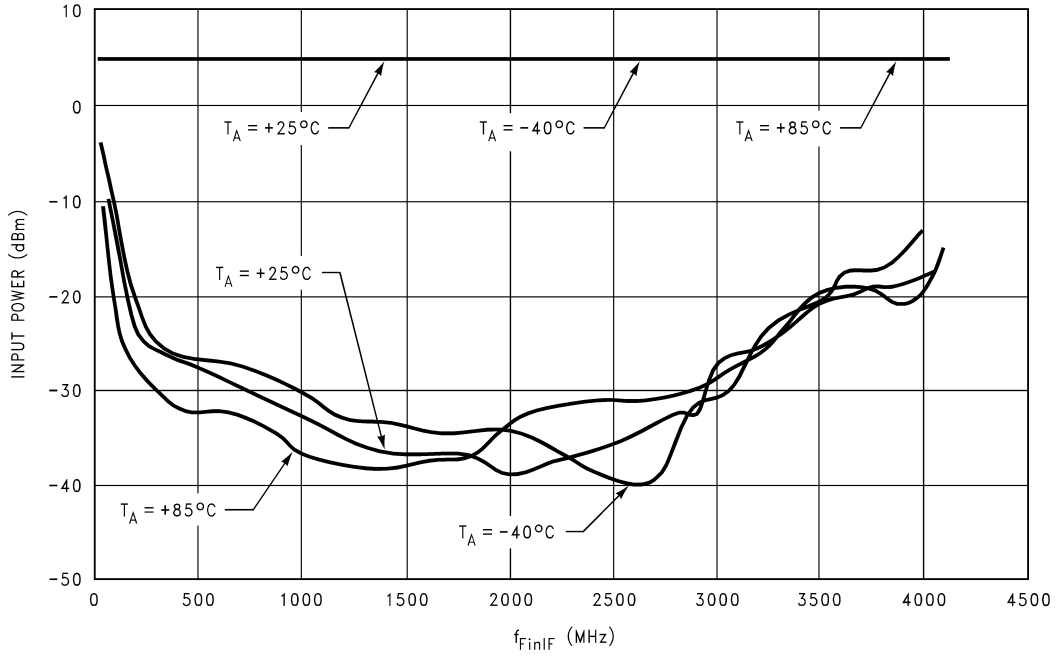


200535A1

# Typical Performance Characteristics

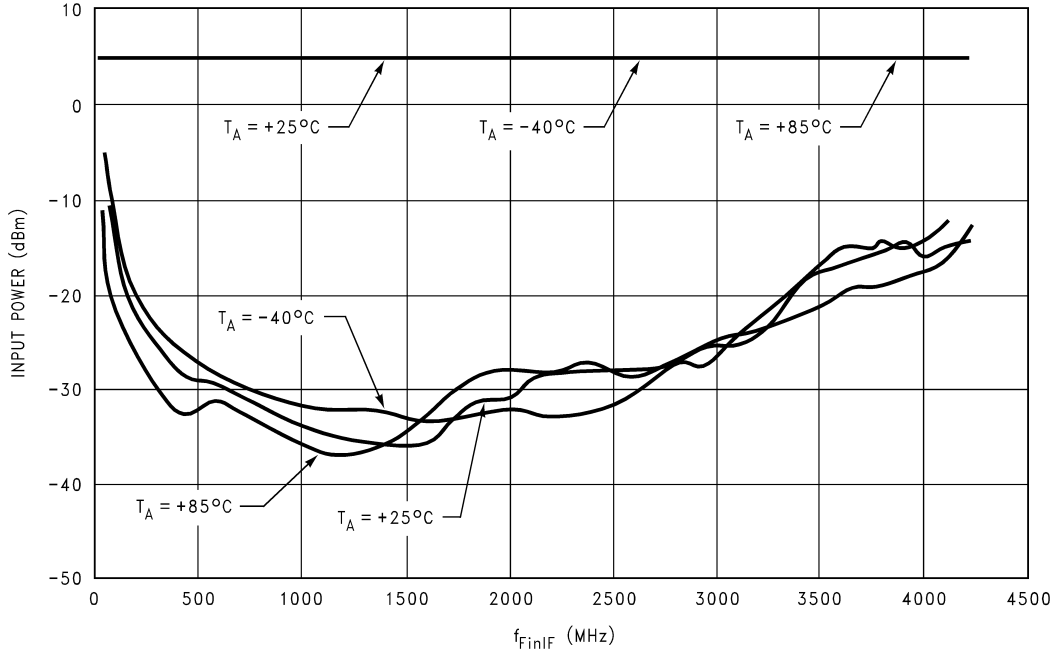
## Sensitivity (Continued)

**LMX2434 FinIF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.25V**



200535A2

**LMX2434 FinIF Input Power Vs Frequency**  
**V<sub>CC</sub> = EN = 2.75V**

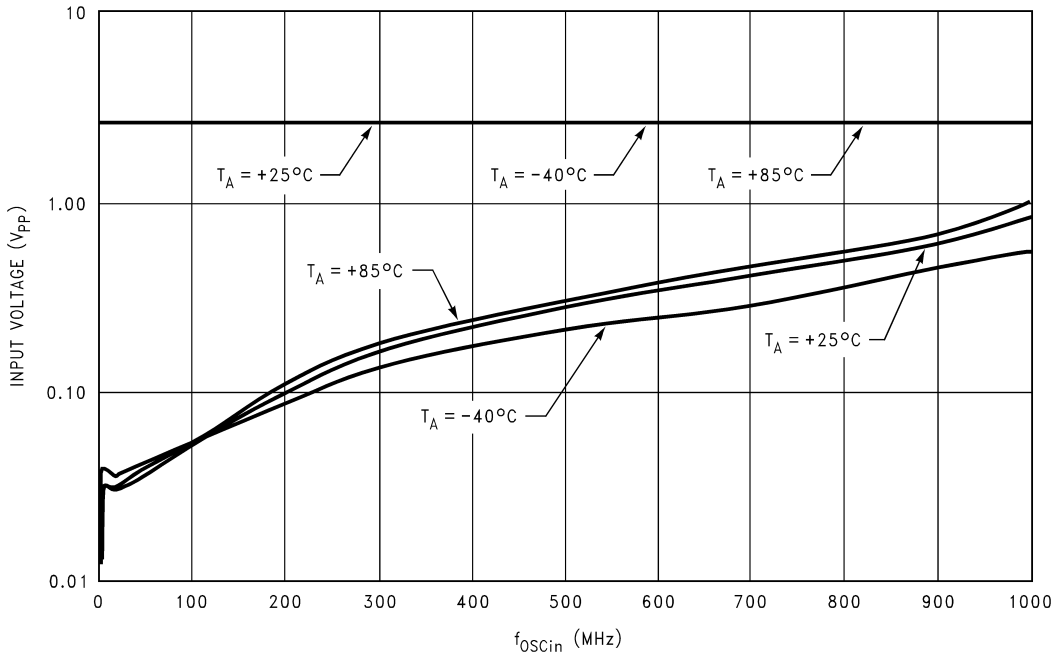


200535A3

# Typical Performance Characteristics

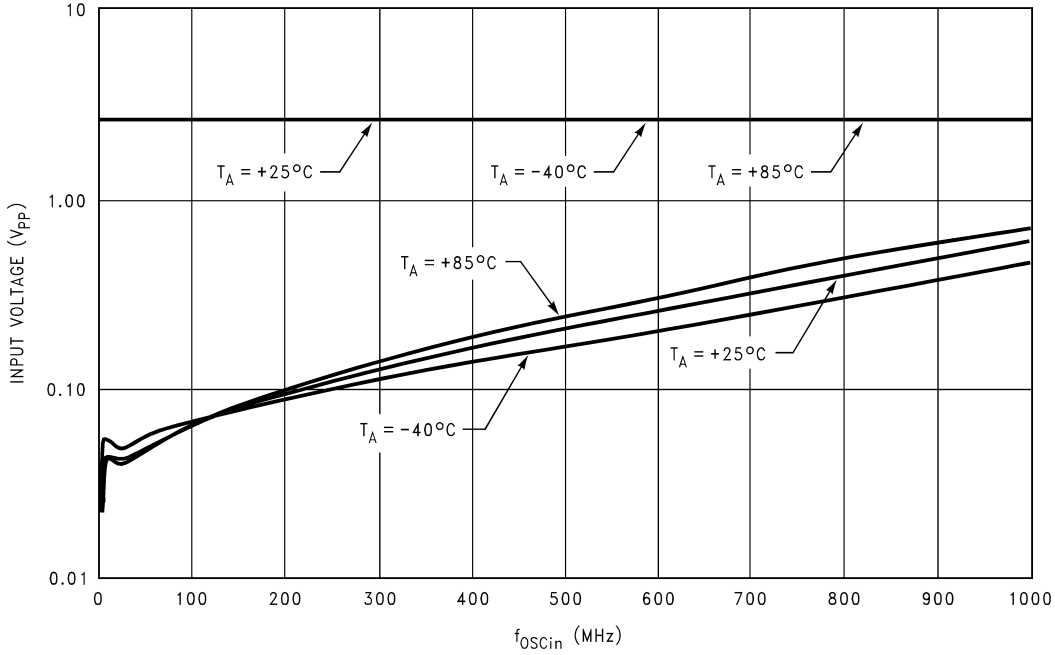
## Sensitivity (Continued)

**LMX243x OSCin Input Voltage Vs Frequency**  
**V<sub>CC</sub> = EN = 2.25V**



200535A4

**LMX243x OSCin Input Voltage Vs Frequency**  
**V<sub>CC</sub> = EN = 2.75V**

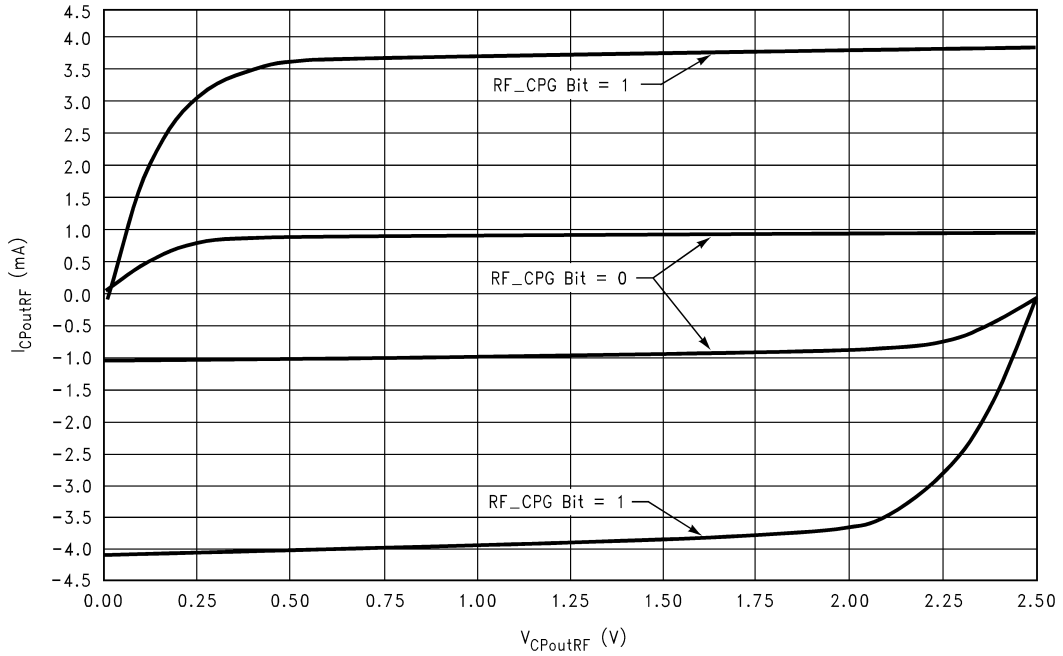


200535A5

# Typical Performance Characteristics

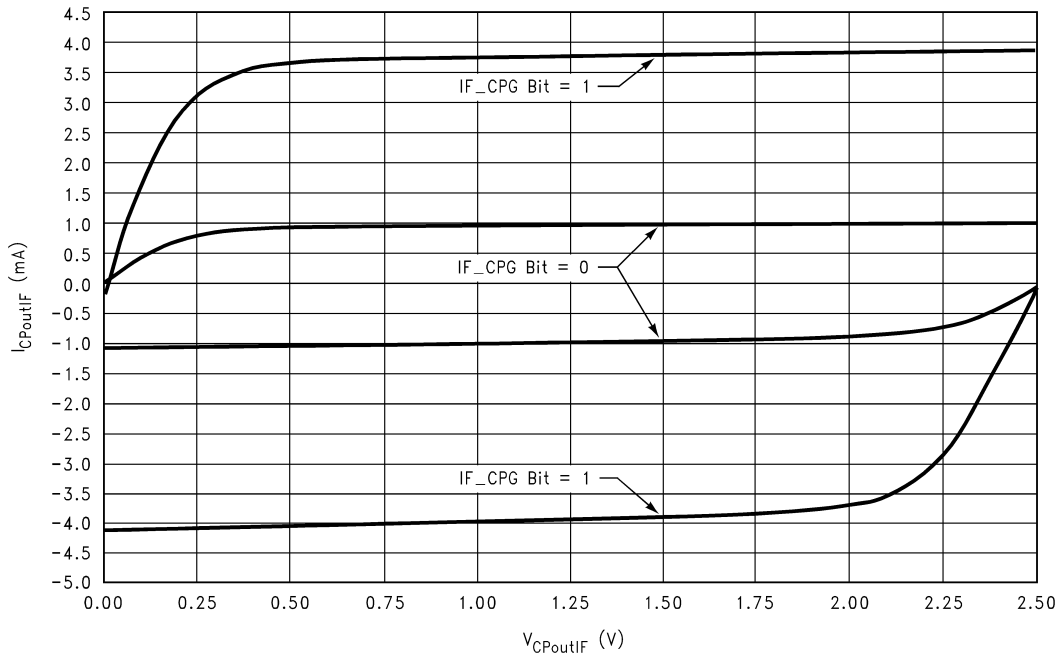
## Charge Pump

**LMX243x RF Charge Pump Sweeps**  
 $V_{CC} = EN = 2.50V$   
 $-40^{\circ}C \leq T_A \leq +85^{\circ}C$



200535A6

**LMX243x IF Charge Pump Sweeps**  
 $V_{CC} = EN = 2.50V$   
 $-40^{\circ}C \leq T_A \leq +85^{\circ}C$

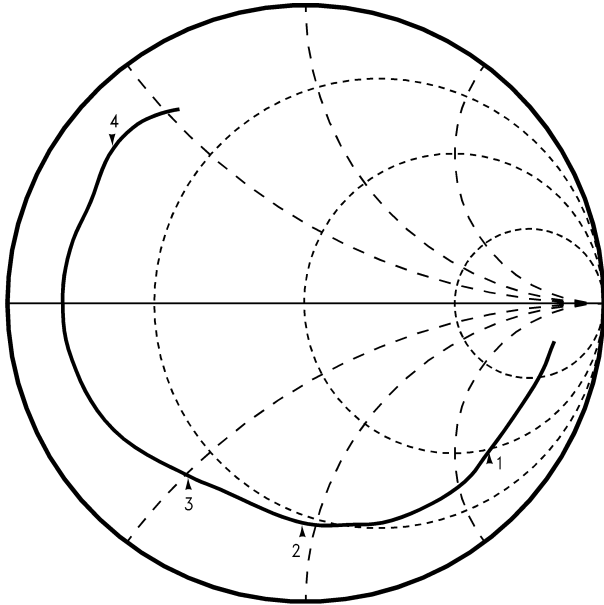


200535A7

# Typical Performance Characteristics

## Input Impedance

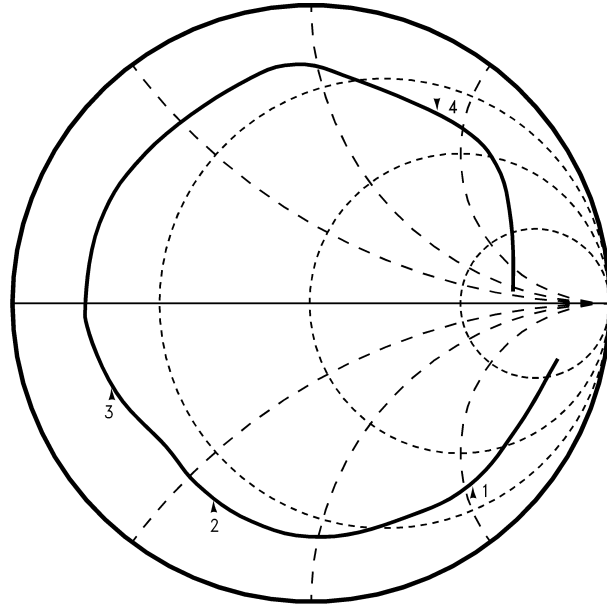
**LMX243x UTCSP FinRF Input Impedance**  
 $V_{CC} = EN = 2.50V, T_A = +25^\circ C$



Marker 1 = 900 MHz  
 Marker 2 = 1900 MHz  
 Marker 3 = 2500 MHz  
 Marker 4 = 5000 MHz

200535A8

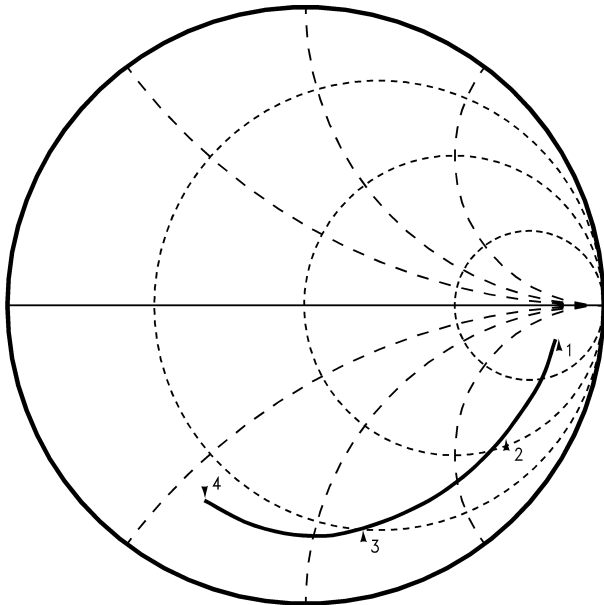
**LMX243x TSSOP FinRF Input Impedance**  
 $V_{CC} = EN = 2.50V, T_A = +25^\circ C$



Marker 1 = 900 MHz  
 Marker 2 = 1900 MHz  
 Marker 3 = 2500 MHz  
 Marker 4 = 5000 MHz

200535A9

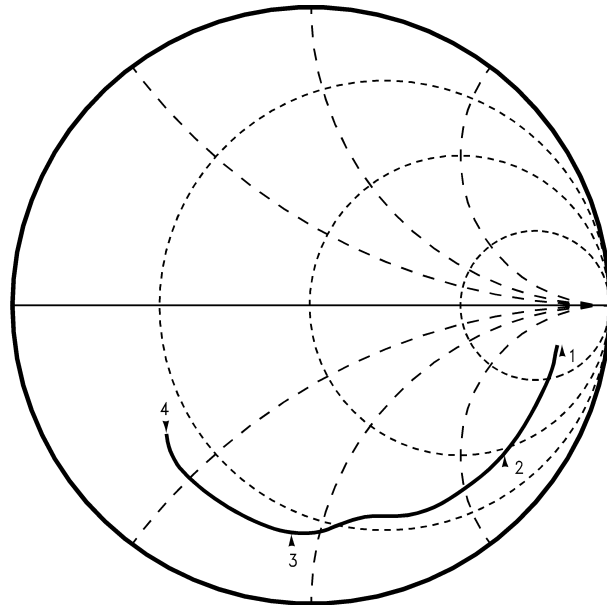
**LMX243x UTCSP FinIF Input Impedance**  
 $V_{CC} = EN = 2.50V, T_A = +25^\circ C$



Marker 1 = 100 MHz  
 Marker 2 = 900 MHz  
 Marker 3 = 1900 MHz  
 Marker 4 = 2500 MHz

200535B0

**LMX243x TSSOP FinIF Input Impedance**  
 $V_{CC} = EN = 2.50V, T_A = +25^\circ C$



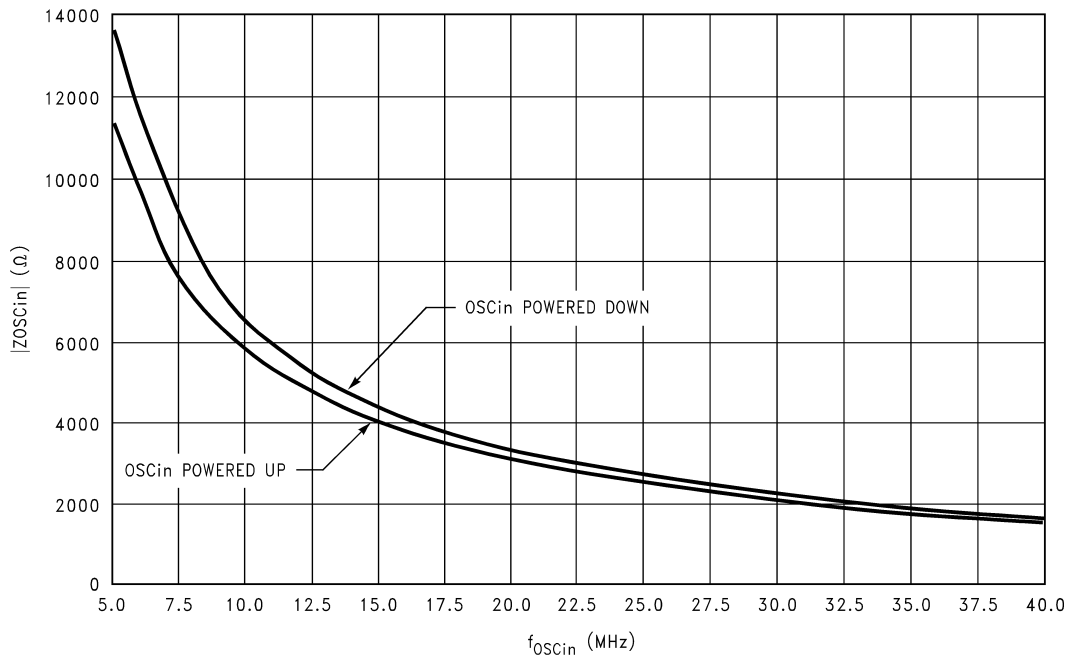
Marker 1 = 100 MHz  
 Marker 2 = 900 MHz  
 Marker 3 = 1900 MHz  
 Marker 4 = 2500 MHz

200535B1

# Typical Performance Characteristics

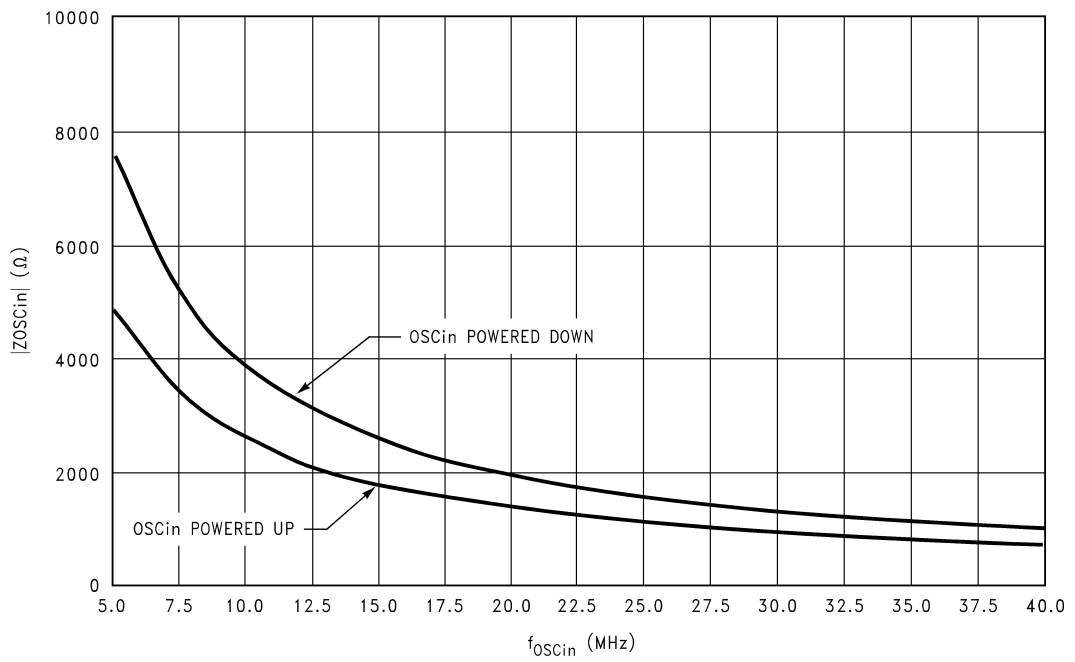
## Input Impedance (Continued)

**LMX243x UTCSP OSCin Input Impedance Vs Frequency**  
**V<sub>CC</sub> = EN = 2.50V**  
**T<sub>A</sub> = +25°C**



200535B2

**LMX233xU TSSOP OSCin Input Impedance Vs Frequency**  
**V<sub>CC</sub> = EN = 2.50V**  
**T<sub>A</sub> = +25°C**



200535B3

## LMX243x UTCSP FinRF Input Impedance Table

V<sub>CC</sub> = EN = 2.50V, T<sub>A</sub> = +25°C

f <sub>FinRF</sub> (MHz)	Γ	Angle (Γ) (°)	Re {Z <sub>FinRF</sub> } (Ω)	Im {Z <sub>FinRF</sub> } (Ω)	Z <sub>FinRF</sub>   (Ω)
100	0.86	-8.63	334.27	-339.55	476.48
200	0.86	-10.72	265.44	-313.48	410.77
300	0.85	-13.48	202.09	-281.42	346.46
400	0.84	-17.01	150.76	-245.31	287.93
500	0.83	-21.05	112.18	-212.85	240.60
600	0.82	-25.32	85.96	-185.41	204.37
700	0.82	-29.78	67.32	-162.49	175.88
800	0.81	-34.35	54.27	-143.15	153.09
900	0.80	-39.02	44.76	-127.07	134.72
1000	0.80	-43.83	37.32	-113.62	119.59
1100	0.79	-48.76	31.65	-102.07	106.86
1200	0.79	-53.90	27.30	-91.89	95.86
1300	0.78	-59.07	23.84	-82.83	86.19
1400	0.78	-64.41	21.34	-74.84	77.82
1500	0.77	-70.04	19.20	-67.56	70.24
1600	0.76	-75.84	17.46	-60.88	63.33
1700	0.75	-82.06	16.27	-54.72	57.09
1800	0.73	-88.56	15.36	-48.89	51.25
1900	0.72	-95.19	14.90	-43.34	45.83
2000	0.70	-101.45	14.32	-38.66	41.23
2100	0.68	-107.85	14.10	-34.26	37.05
2200	0.67	-114.12	13.81	-30.35	33.34
2300	0.66	-120.12	13.27	-27.09	30.17
2400	0.66	-126.01	12.50	-24.00	27.06
2500	0.67	-131.82	11.68	-21.22	24.22
2600	0.69	-137.96	10.55	-18.24	21.07
2700	0.71	-144.21	9.53	-15.58	18.26
2800	0.72	-150.25	8.55	-12.92	15.49
2900	0.74	-156.23	7.75	-10.25	12.85
3000	0.75	-161.92	7.22	-7.77	10.61
3100	0.76	-167.18	6.87	-5.48	8.79
3200	0.77	-172.05	6.63	-3.42	7.46
3300	0.77	-177.55	6.40	-1.49	6.57
3400	0.78	179.16	6.18	0.35	6.19
3500	0.79	174.92	5.99	2.18	6.37
3600	0.79	170.77	5.85	3.99	7.08
3700	0.80	166.54	5.74	5.80	8.16
3800	0.80	162.52	5.73	7.56	9.49
3900	0.80	158.74	5.73	9.22	10.86
4000	0.80	155.06	5.68	10.84	12.24
4100	0.80	151.49	5.69	12.38	13.62
4200	0.80	148.28	5.70	13.78	14.91
4300	0.80	146.02	5.73	14.88	15.95
4400	0.80	144.12	5.60	15.84	16.80
4500	0.82	142.31	5.41	16.66	17.52
4600	0.83	140.78	5.29	17.42	18.21
4700	0.83	139.65	5.14	17.95	18.67
4800	0.84	138.75	4.99	18.38	19.05

**LMX243x UTCSP FinRF Input Impedance Table** (Continued)V<sub>CC</sub> = EN = 2.50V, T<sub>A</sub> = +25°C

f <sub>FinRF</sub> (MHz)	Γ	Angle (Γ) (°)	Re {Z <sub>FinRF</sub> } (Ω)	Im {Z <sub>FinRF</sub> } (Ω)	Z <sub>FinRF</sub>   (Ω)
4900	0.84	137.79	4.84	18.85	19.46
5000	0.84	136.82	4.92	19.79	20.39
5100	0.84	135.77	4.88	18.89	19.51
5200	0.84	134.64	4.99	20.44	21.04
5300	0.84	133.33	5.11	21.16	21.77
5400	0.84	131.68	5.25	21.96	22.58
5500	0.83	129.77	5.43	23.01	23.64
5600	0.83	127.55	5.70	24.16	24.82
5700	0.82	125.41	6.03	25.33	26.04
5800	0.82	123.35	6.42	26.41	27.18
5900	0.81	121.68	6.75	27.30	28.12
6000	0.80	120.42	7.11	28.00	28.89

## LMX243x TSSOP FinRF Input Impedance Table

V<sub>CC</sub> = EN = 2.50V, T<sub>A</sub> = +25°C

f <sub>FinRF</sub> (MHz)	Γ	Angle (Γ) (°)	Re {Z <sub>FinRF</sub> } (Ω)	Im {Z <sub>FinRF</sub> } (Ω)	Z <sub>FinRF</sub>   (Ω)
100	0.86	-12.47	214.61	-314.33	380.61
200	0.85	-15.35	166.75	-270.14	317.46
300	0.84	-19.41	122.76	-228.38	259.28
400	0.83	-24.22	89.48	-193.48	213.17
500	0.82	-28.97	67.73	-167.98	181.12
600	0.82	-33.65	52.07	-148.64	157.50
700	0.82	-38.37	41.64	-131.88	138.30
800	0.82	-43.22	34.60	-117.36	122.35
900	0.81	-48.37	29.69	-104.33	108.47
1000	0.80	-53.84	25.88	-92.74	96.28
1100	0.79	-59.80	22.78	-82.21	85.31
1200	0.78	-66.29	20.17	-72.67	75.42
1300	0.77	-73.30	17.88	-64.06	66.51
1400	0.76	-80.74	15.93	-56.21	58.42
1500	0.75	-88.27	14.50	-49.36	51.45
1600	0.74	-95.87	13.27	-43.30	45.29
1700	0.73	-103.41	12.42	-37.96	39.94
1800	0.72	-110.77	11.67	-33.20	35.19
1900	0.71	-118.23	11.20	-28.78	30.88
2000	0.70	-125.46	11.25	-24.74	27.18
2100	0.68	-131.35	11.37	-21.60	24.41
2200	0.68	-137.19	10.94	-18.79	21.74
2300	0.68	-143.41	10.37	-15.88	18.97
2400	0.69	-149.45	9.70	-13.18	16.36
2500	0.71	-156.15	8.62	-10.26	13.40
2600	0.73	-163.87	7.79	-6.92	10.42
2700	0.74	-171.33	7.47	-3.71	8.34
2800	0.75	-178.24	7.30	0.76	7.34
2900	0.75	174.91	7.24	2.18	7.56
3000	0.75	168.09	7.33	5.12	8.94
3100	0.74	161.11	7.53	8.14	11.09
3200	0.74	153.92	7.83	11.30	13.75
3300	0.74	146.42	8.19	14.72	16.85
3400	0.74	138.67	8.59	18.36	20.27
3500	0.74	130.89	8.97	22.22	23.96
3600	0.75	123.33	9.30	26.23	27.83
3700	0.76	116.17	9.54	30.32	31.79
3800	0.77	109.55	9.74	34.42	35.77
3900	0.78	103.54	9.91	38.43	39.69
4000	0.79	98.25	10.20	42.23	43.44
4100	0.79	93.38	10.71	45.97	47.20
4200	0.79	88.86	11.70	49.59	50.95
4300	0.78	85.10	13.43	52.63	54.32
4400	0.77	82.09	14.79	55.23	57.18
4500	0.77	78.59	16.13	58.48	60.66
4600	0.76	74.73	17.90	62.30	64.82
4700	0.76	70.66	19.89	66.66	69.56
4800	0.75	66.05	22.50	72.05	75.48

**LMX243x TSSOP FinRF Input Impedance Table** (Continued)V<sub>CC</sub> = EN = 2.50V, T<sub>A</sub> = +25°C

<b>f<sub>FinRF</sub></b> <b>(MHz)</b>	<b> Γ </b>	<b>Angle (Γ)</b> <b>(°)</b>	<b>Re {Z<sub>FinRF</sub>}</b> <b>(Ω)</b>	<b>Im {Z<sub>FinRF</sub>}</b> <b>(Ω)</b>	<b> Z<sub>FinRF</sub> </b> <b>(Ω)</b>
4900	0.75	61.68	25.37	77.73	81.77
5000	0.75	57.35	28.56	84.19	88.90
5100	0.76	53.11	31.70	91.39	96.73
5200	0.77	48.79	34.78	100.34	106.20
5300	0.78	43.56	40.56	112.59	119.67
5400	0.78	38.11	52.53	125.62	136.16
5500	0.76	32.89	71.05	135.74	153.21
5600	0.73	27.85	95.57	142.32	171.43
5700	0.71	21.89	133.18	141.32	194.19
5800	0.68	15.38	177.08	116.75	212.10
5900	0.65	9.47	207.23	77.49	221.24
6000	0.64	4.15	222.92	35.24	225.69

## LMX243x UTCSP FinIF Input Impedance Table

$V_{CC} = EN = 2.50V$ ,  $T_A = +25^\circ C$

$f_{FinIF}$ (MHz)	$ \Gamma $	Angle ( $\Gamma$ ) ( $^\circ$ )	Re {ZFinIF} ( $\Omega$ )	Im {ZFinIF} ( $\Omega$ )	ZFinIF  ( $\Omega$ )
100	0.87	-6.19	446.34	-341.41	561.94
200	0.86	-8.10	353.77	-328.44	482.73
300	0.85	-10.98	257.50	-300.77	395.94
400	0.84	-14.21	188.33	-268.39	327.87
500	0.83	-17.67	141.63	-235.88	275.13
600	0.83	-21.32	109.44	-206.86	234.03
700	0.82	-25.13	86.57	-182.41	201.91
800	0.81	-29.04	70.47	-161.46	176.17
900	0.80	-32.99	58.90	-144.27	155.83
1000	0.79	-36.73	50.96	-130.45	140.05
1100	0.79	-40.28	44.21	-120.14	128.02
1200	0.79	-44.11	37.38	-111.08	117.20
1300	0.79	-48.38	31.82	-101.96	106.81
1400	0.79	-52.91	27.95	-93.09	97.20
1500	0.78	-57.26	25.34	-85.47	89.15
1600	0.77	-61.56	23.28	-78.74	82.11
1700	0.77	-66.01	20.98	-72.74	75.71
1800	0.77	-71.39	18.40	-66.32	68.83
1900	0.77	-77.74	15.22	-59.40	61.32
2000	0.76	-84.72	15.02	-52.48	54.59
2100	0.73	-92.59	14.39	-46.17	48.36
2200	0.71	-100.18	14.07	-40.46	42.84
2300	0.69	-107.33	13.94	-35.79	38.41
2400	0.68	-114.48	13.37	-31.55	34.27
2500	0.68	-118.42	12.71	-28.62	31.32

## LMX243x TSSOP FinIF Input Impedance Table

$V_{CC} = EN = 2.50V$ ,  $T_A = +25^\circ C$

$f_{FinIF}$ (MHz)	$ \Gamma $	Angle ( $\Gamma$ ) ( $^\circ$ )	Re {ZFinIF} ( $\Omega$ )	Im {ZFinIF} ( $\Omega$ )	ZFinIF  ( $\Omega$ )
100	0.87	-7.11	400.44	-348.14	530.62
200	0.86	-9.92	288.69	-318.81	430.10
300	0.85	-13.64	198.42	-281.45	344.36
400	0.84	-17.47	141.73	-246.13	284.02
500	0.84	-21.42	105.75	-214.58	239.22
600	0.83	-25.39	82.00	-188.43	205.50
700	0.83	-29.46	65.48	-166.34	178.76
800	0.82	-33.67	53.78	-147.46	156.96
900	0.81	-37.99	45.17	-131.83	139.35
1000	0.80	-42.47	38.82	-117.87	124.10
1100	0.79	-46.96	33.93	-106.36	111.64
1200	0.79	-51.67	29.53	-96.20	100.63
1300	0.78	-57.02	25.26	-86.47	90.08
1400	0.77	-63.11	22.15	-76.93	80.06
1500	0.76	-69.26	20.49	-68.42	71.42
1600	0.74	-74.82	19.54	-61.59	64.62
1700	0.74	-79.79	17.70	-56.35	59.06
1800	0.74	-86.55	15.09	-50.74	52.94
1900	0.74	-94.37	13.38	-44.56	46.53
2000	0.73	-101.95	12.62	-38.87	40.87
2100	0.72	-108.92	12.21	-34.18	36.30
2200	0.71	-115.63	11.65	-30.11	32.29
2300	0.71	-123.23	11.13	-25.97	28.25
2400	0.69	-131.44	11.08	-21.74	24.40
2500	0.67	-138.35	11.54	-18.31	21.64

## LMX243x UTCSP OSCin Input Impedance Table

$V_{CC} = EN = 2.50V$ ,  $T_A = +25^{\circ}C$

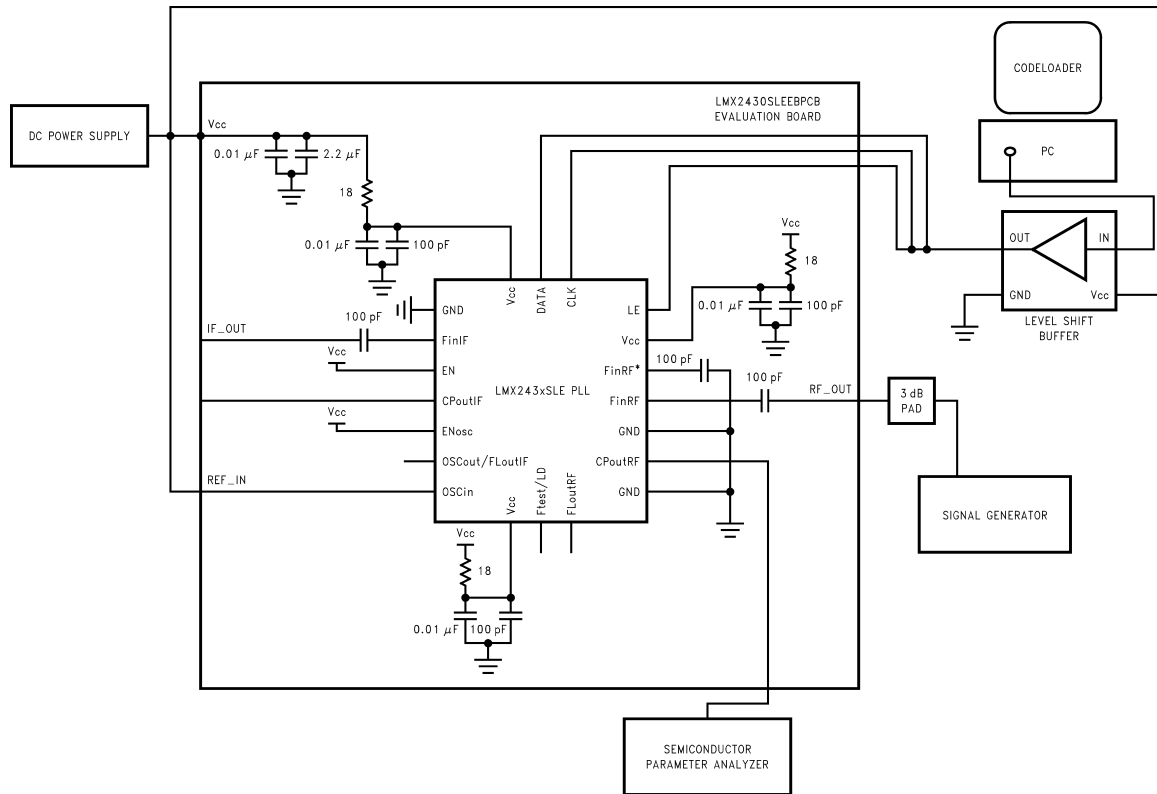
f <sub>oscin</sub> (MHz)	ENosc = 1			ENosc = 0		
	Re {ZOSCin} ( $\Omega$ )	Im {ZOSCin} ( $\Omega$ )	ZOSCin  ( $\Omega$ )	Re {ZOSCin} ( $\Omega$ )	Im {ZOSCin} ( $\Omega$ )	ZOSCin  ( $\Omega$ )
5.0	5032.01	-10120.58	11302.53	2641.63	-13293.58	13553.50
7.5	2529.17	-7382.23	7803.46	1108.82	-8932.61	9001.17
10.0	1412.10	-5693.56	5866.06	526.74	-6461.11	6482.55
12.5	1051.18	-4930.80	5041.60	330.16	-5452.11	5462.10
15.0	710.63	-4099.58	4160.72	233.66	-4455.98	4462.10
17.5	545.87	-3584.60	3625.92	212.67	-3822.33	3828.24
20.0	442.32	-3125.21	3156.35	192.16	-3306.06	3311.64
22.5	314.15	-2806.10	2823.63	112.07	-2963.67	2965.79
25.0	316.48	-2518.94	2538.75	143.65	-2657.93	2661.81
27.5	223.49	-2280.02	2290.95	84.09	-2405.34	2406.81
30.0	196.90	-2105.11	2114.30	40.38	-2196.07	2196.45
32.5	175.38	-1942.45	1950.35	77.29	-2044.88	2046.34
35.0	158.95	-1816.83	1823.77	67.31	-1898.92	1900.12
37.5	137.80	-1701.59	1707.16	51.11	-1775.84	1776.58
40.0	114.20	-1573.28	1577.42	50.39	-1652.06	1652.83

## LMX243x TSSOP OSCin Input Impedance Table

V<sub>CC</sub> = EN = 2.50V, T<sub>A</sub> = +25°C

f <sub>oscin</sub> (MHz)	ENosc = 1			ENosc = 0		
	Re {ZOSCin} (Ω)	Im {ZOSCin} (Ω)	ZOSCin  (Ω)	Re {ZOSCin} (Ω)	Im {ZOSCin} (Ω)	ZOSCin  (Ω)
5.0	1111.30	-4814.09	4940.69	654.13	-7449.33	7477.99
7.5	628.81	-3411.80	3469.26	388.42	-5150.60	5165.22
10.0	359.99	-2623.46	2648.04	237.72	-3892.18	3899.44
12.5	284.12	-2065.00	2084.46	159.00	-2988.66	2992.88
15.0	203.53	-1801.24	1812.70	152.53	-2597.16	2601.63
17.5	134.32	-1548.50	1554.32	82.41	-2222.34	2223.86
20.0	109.85	-1343.30	1347.78	60.86	-1956.99	1957.94
22.5	80.56	-1192.73	1195.45	47.56	-1730.53	1731.18
25.0	69.37	-1063.72	1065.98	47.47	-1553.43	1554.15
27.5	60.10	-973.84	975.70	37.83	-1414.54	1415.04
30.0	50.30	-890.31	891.73	34.80	-1290.03	1290.50
32.5	45.52	-816.01	817.28	29.72	-1188.88	1189.25
35.0	41.55	-758.24	759.38	31.50	-1096.89	1097.35
37.5	37.73	-707.57	708.57	23.04	-1024.88	1025.14
40.0	36.09	-661.87	662.86	22.61	-963.11	963.38

## LMX243x Charge Pump Test Setup



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The block diagram above illustrates the setup required to measure the LMX243x device's RF charge pump sink current. The same setup is used for the LMX2430TM Evaluation Board. The purpose of this test is to assess the functionality of the RF charge pump. The IF charge pump is evaluated in the same way.

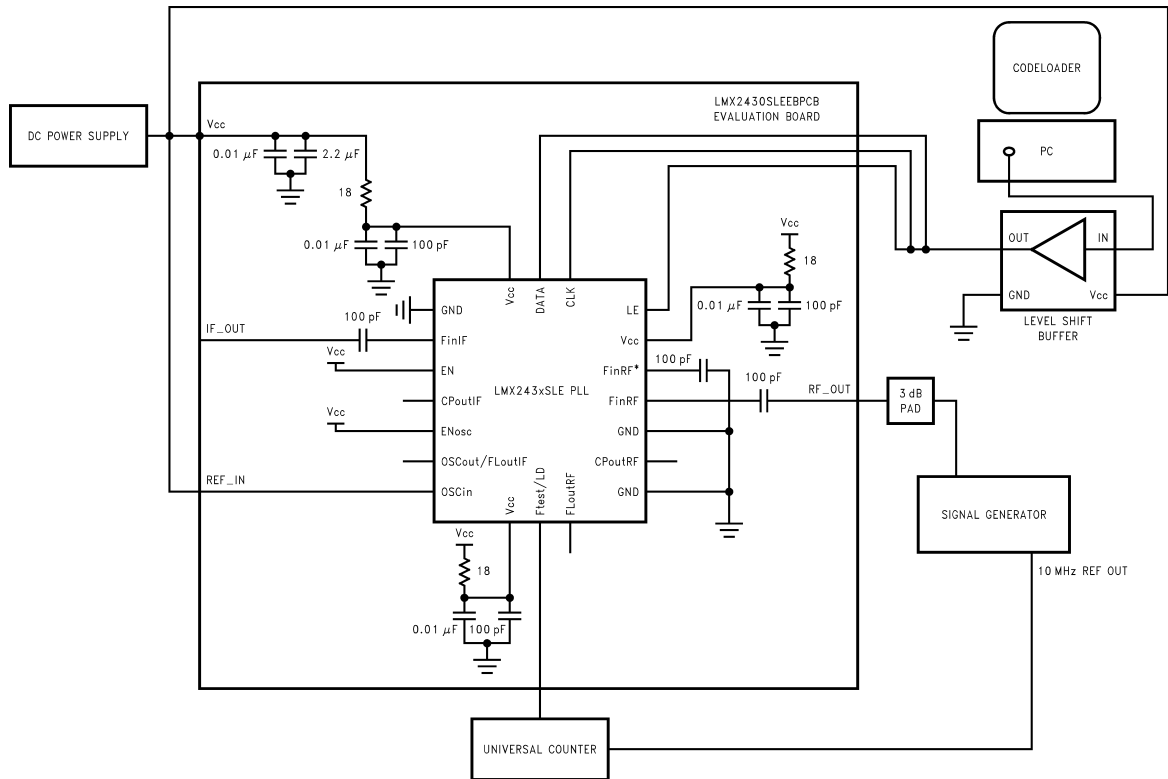
This setup uses an open loop configuration. A power supply is connected to Vcc. By means of a signal generator, a 10 MHz signal is typically applied to the FinRF pin. The signal is one of two inputs to the phase/ frequency detector (PFD). The 3 dB pad provides a 50Ω match between the PLL and the signal generator. The OSCin pin is tied to Vcc. This establishes the other input to the PFD. Alternatively, this input can be tied directly to the ground plane. The EN and ENosc pins are also both tied to Vcc. A Semiconductor Parameter Analyzer is connected to the CPoutRF pin and used to measure the sink, source, and TRI-STATE leakage currents.

Let  $F_r$  represent the frequency of the signal applied to the OSCin pin, which is simply zero in this case (DC), and let  $F_p$  represent the frequency of the signal applied to the FinRF

pin. The PFD is sensitive to the rising edges of  $F_r$  and  $F_p$ . Assuming positive VCO characteristics (RF\_CPP bit = 1); the charge pump turns ON, and sinks current when the first rising edge of  $F_p$  is detected. Since  $F_r$  has no rising edge, the charge pump continues to sink current indefinitely. In order to measure the RF charge pump source current, the RF\_CPP bit is simply set to 0 (negative VCO characteristics) in CodeLoader. Similarly, in order to measure the TRI-STATE leakage current, the RF\_CPT bit is set to 1.

The measurements are typically taken over supply voltage and temperature. The measurements are also typically taken at the HIGH and LOW charge pump current gains. The charge pump current gain can be controlled by the RF\_CPG bit in CodeLoader. Once the charge pump currents are determined, the (i) charge pump output current magnitude variation versus charge pump output voltage, (ii) charge pump output sink current versus charge pump output source current mismatch, and (iii) charge pump output current magnitude versus temperature, can be calculated. Refer to the **Charge Pump Current Specifications Definition** for more details.

## LMX243x FinRF Sensitivity Test Setup



20053589

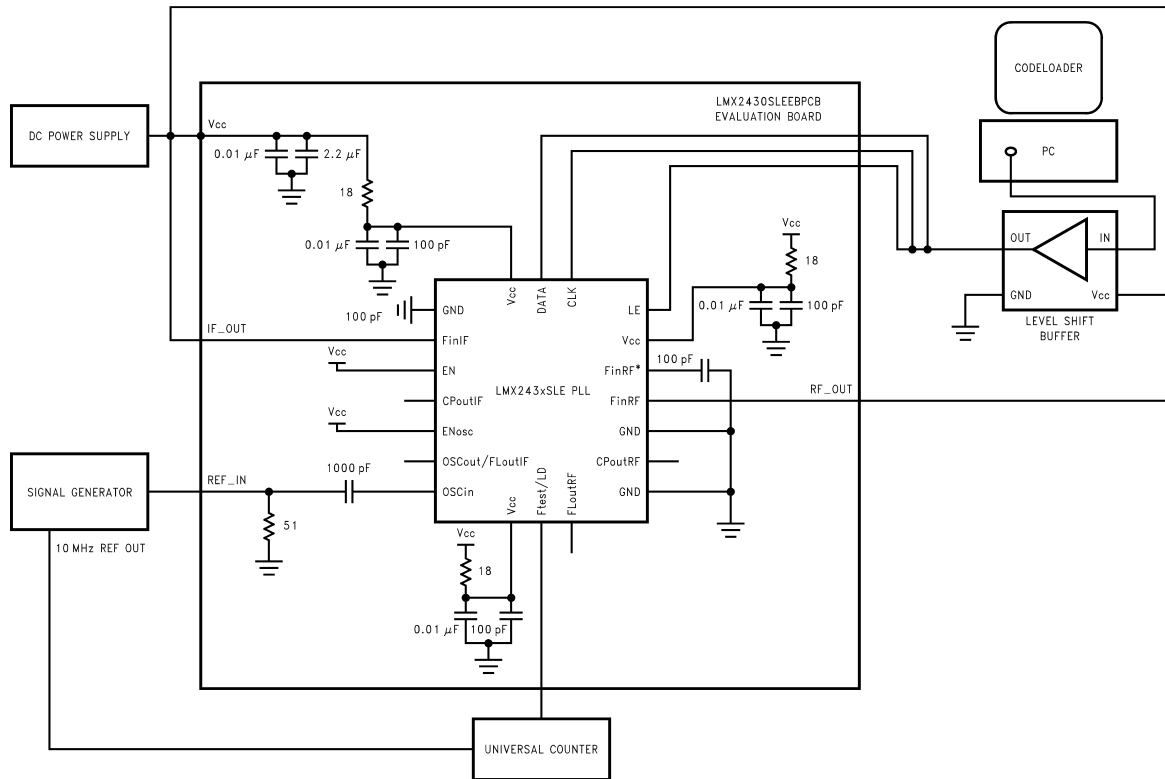
The block diagram above illustrates the setup required to measure the LMX243x device's RF input sensitivity level. The same setup is used for the LMX2430TM Evaluation Board. The purpose of this test is to measure the acceptable signal level to the FinRF input of the PLL chip. Outside the acceptable signal range, the feedback divider begins to divide incorrectly and miscount the frequency. The FinIF sensitivity is evaluated in the same way.

The setup uses an open loop configuration. A power supply is connected to Vcc. The IF PLL is powered down (IF\_PD bit = 1). By means of a signal generator, an RF signal is applied to the FinRF pin. The 3 dB pad provides a 50Ω match between the PLL and the signal generator. The EN, ENosc, and OSCin pins are all tied to Vcc. The N value is typically set to 10000 in CodeLoader, i.e. RF\_B word = 156 and RF\_A word = 16 for RF\_P bit = 0 (LMX2434) or RF\_P bit = 1 (LMX2430 and LMX2433). The feedback divider output is routed to the Ftest/LD pin by selecting the RF\_N/2 Frequency word (MUX[3:0] word = 15) in CodeLoader. A Universal Counter is connected to the Ftest/LD pin and used to monitor the output frequency of the feedback divider. The

expected frequency should be the signal generator frequency divided by twice the corresponding counter value, i.e. 20000. The factor of two comes in because the LMX43x device has an internal /2 circuit which is used to provide a 50% duty cycle.

Sensitivity is typically measured over frequency, supply voltage and temperature. In order to perform the measurement, the temperature, frequency, and supply voltage is set to a fixed value and the power level of the signal at FinRF is varied. Sensitivity is reached when the frequency error of the divided RF input is greater than or equal to 1 Hz. The power attenuation from the cable and the 3 dB pad must be accounted for. The feedback divider will actually miscount if too much or too little power is applied to the FinRF input. Therefore, the allowed input power level will be bounded by the upper and lower sensitivity limits. In a typical application, if the power level to the FinRF input approaches the sensitivity limits, this can introduce spurs or cause degradation to the phase noise. When the power level gets even closer to these limits, or exceeds it, then the RF PLL loses lock.

## LMX243x OSCin Sensitivity Test Setup

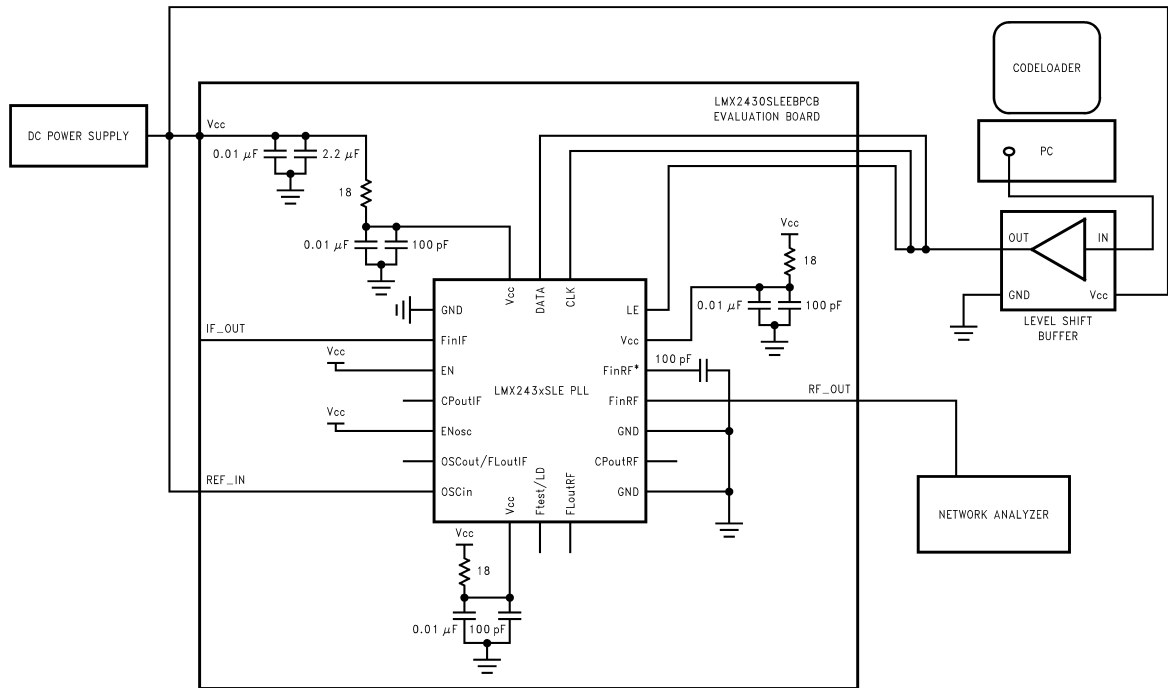


20053590

The block diagram above illustrates the setup required to measure the LMX243x device's OSCin buffer sensitivity level. The same setup is used for the LMX2430TM Evaluation Board. This setup is similar to the FinRF sensitivity setup except that the signal generator is now connected to the OSCin pin and both Fin pins are tied to Vcc. The 51Ω shunt resistor matches the OSCin input to the signal generator. The R counter is typically set to 1000, i.e. RF\_R word = 1000 or IF\_R word = 1000. The reference divider output is routed to the Ftest/LD pin by selecting the RF\_R/ 2 Frequency word (MUX[3:0] word = 14) or the IF\_R/ 2 Frequency word (MUX[3:0] word = 12) in CodeLoader. A Universal Counter is connected to the Ftest/LD pin and is used to monitor the

output frequency of the reference divider. The expected frequency should be the signal generator frequency divided by twice the corresponding counter value, i.e. 2000. The factor of two comes in because the LMX243x device has an internal /2 circuit which is used to provide a 50% duty cycle. In a similar way, sensitivity is typically measured over frequency, supply voltage and temperature. In order to perform the measurement, the temperature, frequency, and supply voltage is set to a fixed value and the power level (voltage level) of the signal at OSCin is varied. Sensitivity is reached when the frequency error of the divided input signal is greater than or equal to 1 Hz.

## LMX243x FinRF Input Impedance Test Setup



20053591

The block diagram above illustrates the setup required to measure the LMX243x device's RF input impedance. The same setup is used for the LMX2430TM Evaluation Board. Measuring the device's input impedance facilitates the design of appropriate matching networks to match the PLL to the VCO, or in more critical situations, to the characteristic impedance of the printed circuit board (PCB) trace, to prevent undesired transmission line effects. The FinIF input impedance is evaluated in the same way.

Before the actual measurements are taken, the Network Analyzer needs to be calibrated, i.e. the error coefficients need to be calculated. The Network Analyzer's calibration standard is used to calculate these coefficients. The calibration standard includes an open, short and a matched load. A 1-port calibration is implemented here.

To calculate the coefficients, the PLL chip is first removed from the PCB. A piece of semi-rigid coaxial cable is then soldered to the pad on the PCB which is equivalent to the FinRF pin on the PLL chip. Proper grounding near the exposed tip of the semi-rigid coaxial cable is required for accurate results. Note that the DC blocking capacitor is removed for this test. The Network Analyzer port is then connected to the other end of the semi-rigid coaxial cable. In

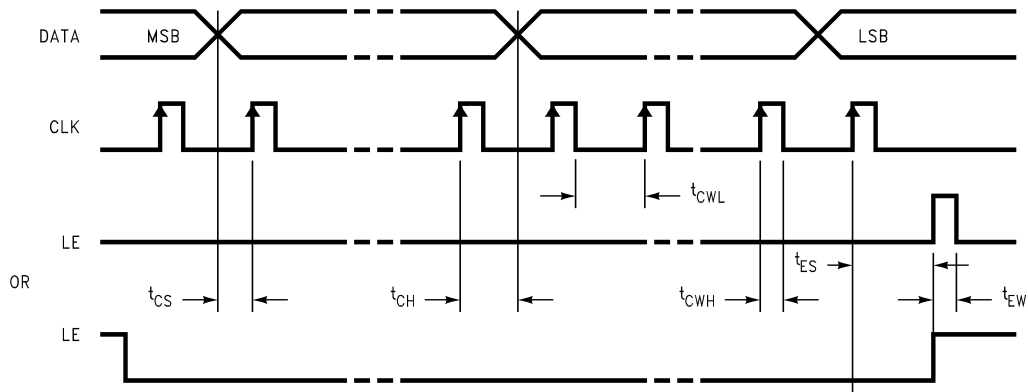
this way, the semi-rigid coaxial cable acts as a transmission line. This transmission line adds electrical length and produces an offset from the reference plane of the Network Analyzer; therefore, it must be included in the calibration. The desired operating frequency is then set. The typical frequency range selected for the LMX243x device's RF synthesizer is from 100 MHz to 6000 MHz.

The Network Analyzer calculates the calibration coefficients based on the measured  $S_{11}$  parameters. With this all done, calibration is now complete.

The PLL chip is then placed on the PCB. A power supply is then connected to Vcc. The EN, ENosc, and OSCin pins are all tied to Vcc. Alternatively, the OSCin pin can be tied to ground. In this setup, the complementary input (FinRF\*) is AC coupled to ground. With the Network Analyzer still connected to the semi-rigid coaxial cable, the measured FinRF impedance is displayed.

The OSCin input impedance is measured in the same way. The impedance is measured when the oscillator buffer is powered up (ENosc is set HIGH) and when the oscillator buffer is powered down (ENosc pin is set LOW).

## LMX243x Serial Data Input Timing



20053510

**Notes:**

1. DATA is clocked into the 24-bit shift register on the rising edge of CLK
2. The MSB of DATA is shifted in first.

## 1.0 Functional Description

The basic phase-lock-loop (PLL) configuration consists of a high-stability crystal reference oscillator, a frequency synthesizer such as the National Semiconductor LMX243x, a voltage controlled oscillator (VCO), and a passive loop filter. The frequency synthesizer includes a phase detector, current mode charge pump, programmable reference R and feedback N frequency dividers. The VCO frequency is established by dividing the crystal reference signal down via the reference divider to obtain a comparison reference frequency. This reference signal,  $f_r$ , is then presented to the input of a phase/ frequency detector and compared with the feedback signal,  $f_p$ , which was obtained by dividing the VCO frequency down by way of the feedback divider. The phase/ frequency detector measures the phase error between the  $f_r$  and  $f_p$  signals and outputs control signals that are directly proportional to the phase error. The charge pump then pumps charge into or out of the loop filter based on the magnitude and direction of the phase error. The loop filter converts the charge into a stable control voltage for the VCO. The phase/frequency detector's function is to adjust the voltage presented to the VCO until the feedback signal's frequency and phase match that of the reference signal. When this "Phase-Locked" condition exists, the VCO frequency will be N times that of the comparison frequency, where N is the feedback divider ratio.

### 1.1 REFERENCE OSCILLATOR INPUT

The reference oscillator frequency for both the RF and IF PLLs is provided from an external reference via the OSCin pin. The reference buffer circuit supports input frequencies from 5 to 40 MHz with a minimum input sensitivity of 0.5 V<sub>PP</sub>. The reference buffer circuit has an approximate V<sub>CC</sub>/2 input threshold and can be driven from an external AC coupled source. Typically, the OSCin pin is connected to the output of a crystal oscillator.

### 1.2 REFERENCE DIVIDERS (R COUNTERS)

The reference dividers divide the reference input signal, OSCin, by a factor of R. The output of the reference divider circuits feeds the reference input of the phase detector. This reference input to the phase detector is often referred to as the comparison frequency. The divide ratio should be chosen such that the maximum phase comparison frequency ( $f_{\text{COMPRF}}$  or  $f_{\text{COMPIF}}$ ) of 10 MHz is not exceeded.

The RF and IF reference dividers are each comprised of 15-bit CMOS binary counters that support a continuous integer divide ratio from 3 to 32767. The RF and IF reference divider circuits are clocked by the output of the reference buffer circuit which is common to both. Refer to **Sections 2.4.1** and **2.7.1** for details on how to program the RF\_R and IF\_R counters.

### 1.3 PRESCALERS

The Fin<sub>RF</sub> and Fin<sub>IF</sub> input pins drive the input of a differential-pair amplifier. The output of the differential-pair amplifier drives a chain of D-type flip-flops in a dual modulus configuration. The output of the prescaler is used to clock the subsequent feedback dividers. The RF PLL complementary inputs can be driven differentially, or the negative input can be AC coupled to ground through an external capacitor for single ended configuration. A 16/17 or a 32/33 prescale ratio can be selected for the 5.0 GHz LMX2434 RF synthesizer. An 8/9 or a 16/17 prescale ratio can be selected for both the

LMX2430 and LMX2433 RF synthesizers. The IF PLL is single ended. An 8/9 or a 16/17 prescale ratio can be selected for the IF synthesizer.

### 1.4 PROGRAMMABLE FEEDBACK DIVIDERS (N COUNTERS)

The programmable feedback dividers operate in concert with the prescalers to divide the input signal, Fin, by a factor of N. The output of the programmable reference divider is provided to the feedback input of the phase detector circuit. The divide ratio should be chosen such that the maximum phase comparison frequency ( $f_{\text{COMPRF}}$  or  $f_{\text{COMPIF}}$ ) of 10 MHz is not exceeded.

The programmable feedback divider circuit is comprised of an A counter (swallow counter) and a B counter (programmable binary counter). For both the LMX2430 and LMX2433, the RF\_A counter is a 4-bit swallow counter, programmable from 0 to 15. The LMX2434 RF\_A counter is a 5-bit swallow counter, programmable from 0 to 31. The LMX243x IF\_A counter is a 4-bit swallow counter, programmable from 0 to 15. For both the LMX2430 and LMX2433, the RF\_B counter is a 15-bit binary counter, programmable from 3 to 32767. The LMX2434 RF\_B counter is a 14-bit binary counter, programmable from 3 to 16383. The LMX243x IF\_B is a 14-bit binary counter programmable from 3 to 16383. A continuous integer divide ratio is achieved if  $N \geq P * (P-1)$ , where P is the value of the prescaler selected. Divide ratios less than the minimum continuous divide ratio are achievable as long as the binary programmable counter value is greater than the swallow counter value ( $B \geq A$ ). Refer to **Sections 2.5.1.1, 2.5.1.2, 2.5.2.1, 2.5.2.2, 2.8.1, and 2.8.2** for details on how to program the A and B counters. The following equations are useful in determining and programming a particular value of N:

$$N = (P \times B) + A$$

$$F_{\text{in}} = N \times f_{\text{COMP}}$$

#### Definitions:

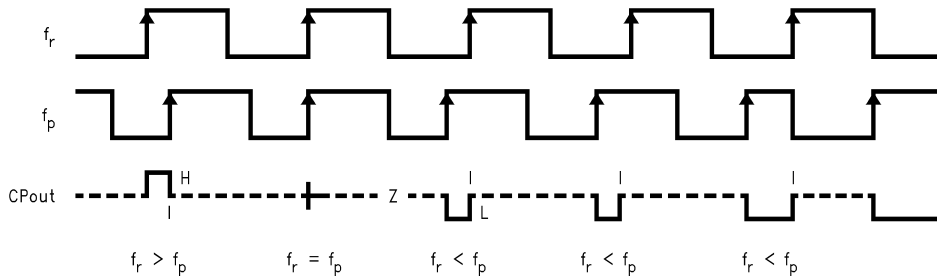
- $f_{\text{COMP}}$ : RF or IF phase detector comparison frequency
  - Fin: RF or IF input frequency
  - A: RF\_A or IF\_A counter value
  - B: RF\_B or IF\_B counter value
  - P: Preset modulus of the dual modulus prescaler
- LMX2430 RF synthesizer: P = 8 or 16  
 LMX2433 RF synthesizer: P = 8 or 16  
 LMX2434 RF synthesizer: P = 16 or 32  
 LMX243x IF synthesizer: P = 8 or 16

### 1.5 PHASE/ FREQUENCY DETECTORS

The RF and IF phase/ frequency detectors (PFD) are driven from their respective N and R counter outputs. The maximum frequency for both the RF and IF phase detector inputs is 10 MHz. The PFD outputs control the respective charge pumps. The polarity of the pump-up or pump-down control signals are programmed using the RF\_CPP or IF\_CPP control bits, depending on whether the RF or IF VCO characteristics are positive or negative. Refer to **Sections 2.4.2** and **2.7.2** for more details. The PFDs have a detection range of  $-2\pi$  to  $+2\pi$ . The PFDs also receive a feedback signal from the charge pump in order to eliminate dead zone.

## 1.0 Functional Description (Continued)

### 1.5.1 Phase Comparator and Internal Charge Pump Characteristics



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#### Notes:

1. The minimum width of the pump-up and pump-down current pulses occur at the CPoutRF or CPoutIF pins when the loop is phase locked.
2. The diagram assumes positive VCO characteristics, i.e. RF\_CPP or IF\_CPP = 1.
3.  $f_r$  is the PFD input from the reference divider (R counter).
4.  $f_p$  is the PFD input from the programmable feedback divider (N counter).
5. CPout refers to either the RF or IF charge pump output.

### 1.6 CHARGE PUMPS

The charge pump directs charge into or out of an external loop filter. The loop filter converts the charge into a stable control voltage which is applied to the tuning input of the VCO. The charge pump steers the VCO control voltage towards  $V_{CC}$  during pump-up events and towards GND during pump-down events. When locked, CPoutRF or CPoutIF are primarily in a TRI-STATE mode with small corrections occurring at the phase comparator rate. The charge pump output current magnitude can be selected by toggling the RF\_CPG or IF\_CPG control bits.

### 1.7 MICROWIRE SERIAL INTERFACE

The programmable register set is accessed via the MICROWIRE serial interface. A low voltage logic interface allows direct connection to 1.8V devices. The interface is comprised of three signal pins: CLK, DATA and LE. Serial data is clocked into the 24-bit shift register on the rising edge of CLK. The last two bits decode the internal control register address. When LE transitions HIGH, DATA stored in the shift register is loaded into one of four control registers depending on the state of the address bits. The MSB of DATA is loaded in first. The synthesizers can be programmed even in power down mode. A complete programming description is provided in **Section 2.0 Programming Description**.

### 1.8 MULTI-FUNCTION OUTPUTS

The LMX243x device's Ftest/LD output pin is a multi-function output that can be configured as a general purpose CMOS TRI-STATE output, push-pull analog lock detect output, open-drain analog lock detect output, digital filtered lock detect output, or used to monitor the output of the various reference divider (R counter) or feedback divider (N counter) circuits. The Ftest/LD control word is used to select the desired output function. When the PLL is in powerdown mode, the Ftest/LD output is disabled and is in a high impedance state. A complete programming description of the multi-function output is provided in **Section 2.10**.

### 1.8.1 Push-Pull Analog Lock Detect Output

An analog lock detect status generated from the phase detector is available on the Ftest/LD output pin if selected. A push-pull configuration can be selected for the lock detect output signal. With this configuration, the lock detect output goes HIGH when the charge pump is inactive. It goes LOW when the charge pump is active during a comparison cycle. Narrow low going pulses are observed when the charge pump turns on.

There are three separate push-pull analog lock detect signals that are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a locked state. External circuitry is required to provide a steady DC signal to indicate when the PLL is in a locked state. Refer to **Section 2.10** for details on how to program the different push-pull analog lock detect options.

### 1.8.2 Open-Drain Analog Lock Detect Output

The lock detect output can be an open-drain configuration. In this configuration, the lock detect output goes to a high impedance state when the charge pump is inactive. It goes LOW when the charge pump is active during a comparison cycle. When a pull-up resistor is used, narrow low going pulses are observed when the charge pump turns on.

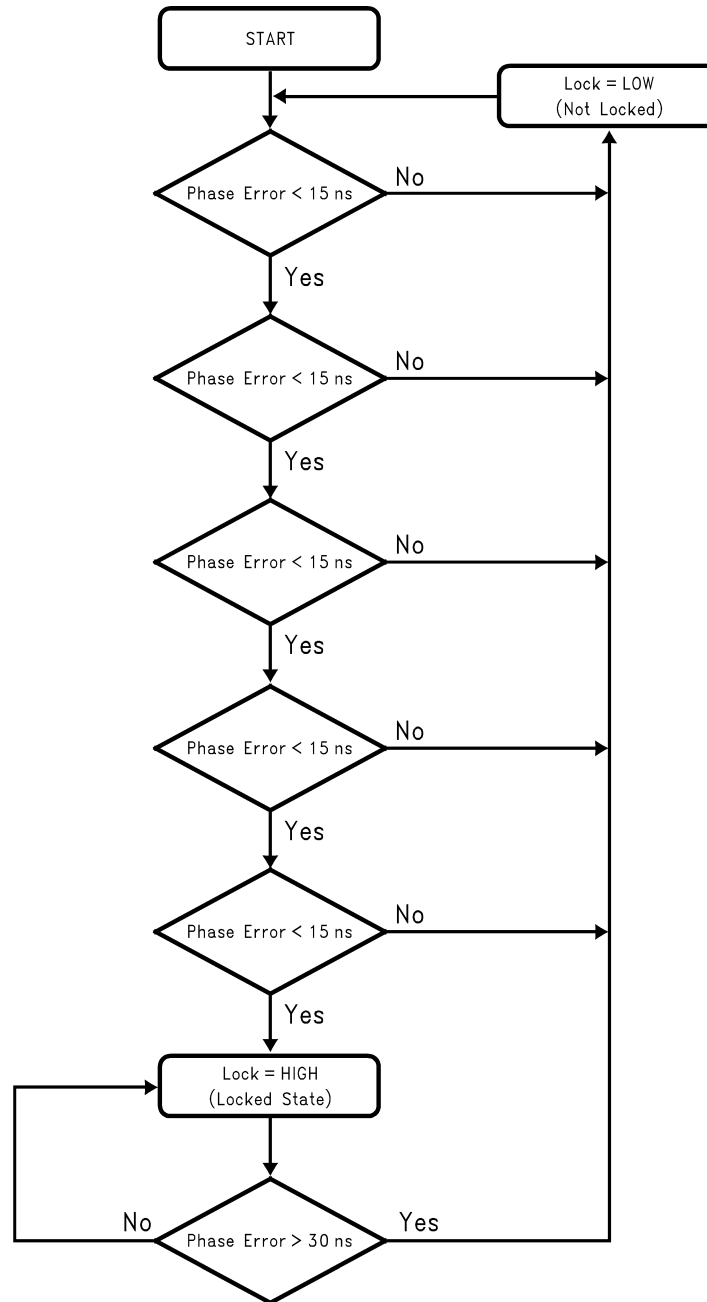
Similarly, three separate open-drain analog lock detect signals are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a locked state. External circuitry is required to provide a steady DC signal to indicate when the PLL is in a locked state. Refer to **Section 2.10** for details on how to program the different open-drain analog lock detect options.

## 1.0 Functional Description (Continued)

### 1.8.3 Digital Filtered Lock Detect Output

A digital filtered lock detect status generated from the phase detector is also available on the Ftest/LD output pin if selected. The lock detect digital filter compares the difference between the phases of the inputs to the PFD to an RC generated delay of approximately 15 ns. If the phase error is less than the 15 ns RC delay for 5 consecutive reference

cycles, the PLL enters a locked state (HIGH). Once in lock, the RC delay is changed to approximately 30 ns. Once the phase error becomes greater than the 30 ns RC delay, the PLL falls out of lock (LOW). When the PLL is in powerdown mode, the Ftest/LD output is forced LOW. A flow chart of the digital filtered lock detect output is shown below.



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Similarly, three separate digital filtered lock detect signals are routed to the multiplexer. Two of these monitor the lock status of the individual synthesizers. The third detects the condition when both the RF and IF synthesizers are in a

locked state. External circuitry is not required when the digital filtered lock detect option is selected. Refer to **Section 2.10** for details on how to program the different digital filtered lock detect options.

## 1.0 Functional Description (Continued)

### 1.8.4 Reference Divider and Feedback Divider Output

The outputs of the various N and R dividers can be monitored by selecting the appropriate Ftest/LD word. This is essential when performing OSCin or Fin sensitivity measurements. Refer to the **LMX243x FinRF Sensitivity Test Setup** or **LMX243x OSCin Sensitivity Test Setup** sections for more details. Note, the R and N outputs that are routed to the Ftest/LD are R/2 and N/2 respectively. The internal /2 circuit is used to provide a 50% duty cycle. Refer to **Section 2.10** for more details on how to route the appropriate divider output to the Ftest/LD pin.

### 1.9 FASTLOCK OUTPUT

The LMX243x Fastlock feature allows a faster loop response time during lock acquisition. The loop response time (lock time) can be approximately halved if the loop bandwidth is doubled. In order to achieve this, the same gain/ phase relationship should be maintained when the loop bandwidth is doubled. When the FLOutRF or OSCout/ FLOutIF pins are configured as FastLock outputs, an open drain device is enabled. The open drain device switches in a resistor parallel, and of equal value, to R2 of the external loop filter. The loop bandwidth is effectively doubled and stability is maintained. Once locked to the correct frequency, the PLL will return to a steady state condition. The LMX243x offers two methods to achieve Fastlock: manual and automatic. Manual Fastlock is achieved by increasing the charge pump current from 1 mA (RF\_CPG/ IF\_CPG Bit = 0) in the steady state mode, to 4 mA (RF\_CPG/ IF\_CPG Bit = 1) in Fastlock mode. Automatic Fastlock is achieved by programming the timeout counter register (RF\_TOC/ IF\_TOC) with the appropriate number of phase comparison cycles that the RF/ IF synthesizer will spend in the Fastlock state. Refer to **Sections 2.6 and 2.9** for details on how to configure the FLOutRF or OSCout/ FLOutIF output to an open drain Fastlock output.

### 1.10 COUNTER RESET

When the RF\_RST/ IF\_RST bit is enabled, both the feedback divider (RF\_N/ IF\_N) and reference divider (RF\_R/ IF\_R) are held at their load point. When the device is programmed to normal operation, both the feedback divider and reference divider are enabled and resume counting in close alignment to each other. Refer to **Sections 2.4.5 and 2.7.5** for more details.

### 1.11 POWER CONTROL

The LMX243x device can be asynchronously powered down when the EN pin is set LOW, independent of the state of the powerdown bits. Note that the OSCout/ FLOutIF pin can still

be enabled if the ENosc pin is set HIGH, independent of the state of the EN pin. This capability allows the oscillator buffer to be used as a crystal oscillator. When EN is set HIGH, powerdown is controlled through the MICROWIRE. The powerdown word is comprised of the RF\_PD/ IF\_PD bit, in conjunction with the RF\_CPT/ IF\_CPT bit. The powerdown control word is used to set the operating mode of the device. Refer to **Sections 2.4.4, 2.5.4, 2.7.4, and 2.8.4** for details on how to program the RF or IF powerdown bits.

When either synthesizer is powered down, the respective prescaler, phase detector, and charge pump circuit is disabled. The CPoutRF/ CPoutIF, FinRF/ FinIF, and FinRF\* pins are all forced to a high impedance state. The reference divider and feedback divider circuits are held at the load point during powerdown. The oscillator buffer is disabled when the ENosc pin is set LOW. The OSCin pin is forced to a HIGH state through an approximate 100 kΩ resistance when this condition exists. When either synthesizer is activated, the respective prescaler, phase detector, charge pump circuit, and the oscillator buffer are all powered up. The feedback divider and reference divider are held at their load point. This allows the reference oscillator, feedback divider, reference divider and prescaler circuitry to reach proper bias levels. After a finite delay, the feedback and reference dividers are enabled and they resume counting in close alignment (the maximum error is one prescaler cycle). The MICROWIRE control register remains active and capable of loading and latching data while in powerdown mode.

#### 1.11.1 Synchronous Powerdown Mode

In this mode, the powerdown function is gated by the charge pump. When the device is configured for synchronous powerdown, the device will enter the powerdown mode upon completion of the next charge pump pulse event.

#### 1.11.2 Asynchronous Powerdown Mode

In this mode, the powerdown function is NOT gated by the completion of a charge pump pulse event. When the device is configured for asynchronous powerdown, the part will go into powerdown mode immediately.

EN Pin	RF_CPT/ IF_CPT Bit	RF_PD/ IF_PD Bit	Operating Mode
0	X	X	Asynchronous Powerdown
1	0	0	PLL Active. Normal Operation
1	1	0	PLL Active. Charge Pump Output in High Impedance State
1	0	1	Synchronous Powerdown
1	1	1	Asynchronous Powerdown

**Note:** X refers to a don't care condition.

## 2.0 Programming Description

### 2.1 MICROWIRE INTERFACE

The 24-bit shift register is loaded via the MICROWIRE interface. The shift register consists of a 21-bit *DATA[20:0] FIELD* and a 3-bit *ADDRESS[2:0] FIELD* as shown below. The ADDRESS FIELD is used to decode the internal control register address. When LE transitions HIGH, DATA stored in the shift register is loaded into one of 6 control registers depending on the state of the ADDRESS bits. The MSB of DATA is loaded into the shift register first. The DATA FIELD assignments are shown in **Section 2.3 CONTROL REGISTER CONTENT MAP**.

MSB																			LSB
DATA[20:0]												ADDRESS[2:0]							
23												3 2			0				

### 2.2 CONTROL REGISTER LOCATION

The ADDRESS[2:0] bits decode the internal register address. The table below shows how the ADDRESS bits are mapped into the target control register.

ADDRESS[2:0] FIELD			Target Register
0	0	0	R0
0	0	1	R1
0	1	0	R2
0	1	1	R3
1	0	0	R4
1	0	1	R5

### 2.3 CONTROL REGISTER CONTENT MAP

The control register content map describes how the bits within each control register are allocated to specific control functions. The bits that are marked 0 should be programmed as such to ensure proper device operation.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD			
R0	MUX[3:2]			RF_RST	RF_CPT	RF_CPG	RF_CPP	RF_R[14:0]															0	0	0
R1	RF_PD	RF_P	LMX2430/33 RF_B[14:0]											LMX2430/33 RF_A[3:0]			0	0	1						
R1	RF_PD	RF_P	LMX2434 RF_B[13:0]											LMX2434 RF_A[4:0]			0	0	1						
R2	0	0	0	0	0	0	0	0	0	0	0	RF_TOC[11:0]										0	1	0	
R3	MUX[1:0]		IF_RST	IF_CPT	IF_CPG	IF_CPP	IF_R[14:0]															0	1	1	
R4	IF_PD	IF_P	0	IF_B[13:0]											IF_A[3:0]			1	0	0					
R5	0	0	0	0	0	0	0	0	0	0	0	IF_TOC[11:0]										1	0	1	

## 2.0 Programming Description (Continued)

### 2.4 R0 REGISTER

The R0 register contains the RF\_R, RF\_CPP, RF\_CPG, RF\_CPT, and RF\_RST control words, in addition to two of the four bits that compose the MUX control word. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD			
R0	MUX[3:2]			RF_RST	RF_CPT	RF_CPG	RF_CPP	RF_R[14:0]															0	0	0

#### 2.4.1 RF\_R[14:0] - RF Synthesizer Programmable Reference Divider (R Counter) (R0[17:3])

The RF reference divider (RF\_R) can be programmed to support divide ratios from 3 to 32767. Divide ratios less than 3 are prohibited.

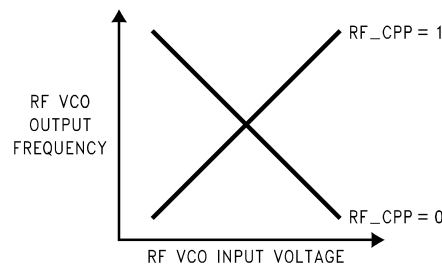
Divide Ratio	RF_R[14:0]															
	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1	
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	

#### 2.4.2 RF\_CPP - RF Synthesizer Phase Detector Polarity (R0[18])

The RF\_CPP bit is used to control the RF synthesizer's phase/ frequency detector polarity based on the VCO tuning characteristics.

Control Bit	Register Location	Description	Function	
			0	1
RF_CPP	R0[18]	RF Phase/ Frequency Detector Polarity	RF VCO Negative Tuning Characteristics	RF VCO Positive Tuning Characteristics

**RF VCO Characteristics**



## 2.0 Programming Description (Continued)

### 2.4.3 RF\_CPG - RF Synthesizer Charge Pump Current Gain (R0[19])

The RF\_CPG bit controls the RF synthesizer's charge pump gain. Two gain levels are available.

Control Bit	Register Location	Description	Function	
			0	1
RF_CPG	R0[19]	RF Charge Pump Current Gain	LOW 1 mA	HIGH 4 mA

### 2.4.4 RF\_CPT - RF Synthesizer Charge Pump TRI-STATE (R0[20])

The RF\_CPT bit allows the charge pump to be switched between a normal operating mode and a high impedance output state. This happens asynchronously with the change in the RF\_CPT bit.

Furthermore, the RF\_CPT bit operates in conjunction with the RF\_PD bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.5.4** for more details on how to program the RF\_PD bit.

Control Bit	Register Location	Description	Function	
			0	1
RF_CPT	R0[20]	RF Charge Pump TRI-STATE	RF Charge Pump Normal Operation	RF Charge Pump Output in High Impedance State

### 2.4.5 RF\_RST - RF Synthesizer Counter Reset (R0[21])

The RF\_RST bit resets the RF\_A, RF\_B and RF\_R counters. After removing the reset, the RF\_A and RF\_B counters resume counting in close alignment with the RF\_R counter. The maximum error is one prescaler cycle.

Control Bit	Register Location	Description	Function	
			0	1
RF_RST	R0[21]	RF Counter Reset	RF_A, RF_B and RF_R Normal Operation	RF_A, RF_B and RF_R Reset

## 2.5 R1 REGISTER

The R1 register contains the RF\_A, RF\_B, RF\_P, and RF\_PD control words. The RF\_A and RF\_B control words are used to setup the programmable feedback divider. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD		
R1	RF_PD	RF_P	LMX2430/33 RF_B[14:0]											LMX2430/33 RF_A[3:0]				0	0	1				
R1	RF_PD	RF_P	LMX2434 RF_B[13:0]											LMX2434 RF_A[4:0]				0	0	1				

### 2.5.1 LMX243x RF Synthesizer Swallow Counter

#### 2.5.1.1 RF\_A[3:0] - LMX2430/33 RF Synthesizer Swallow Counter (A Counter) (R1[6:3])

The RF\_A control word is used to setup the RF synthesizer's A counter. For both the LMX2430 and LMX2433, the A counter is a 4-bit swallow counter used in the programmable feedback divider. The RF\_A control word can be programmed to values ranging from 0 to 15.

Divide Ratio	LMX2430/33 RF_A[3:0]			
	3	2	1	0
0	0	0	0	0
1	0	0	0	1
•	•	•	•	•
15	1	1	1	1

## 2.0 Programming Description (Continued)

### 2.5.1.2 RF\_A[4:0] - LMX2434 RF Synthesizer Swallow Counter (A Counter) (R1[7:3])

The LMX2434 A counter is a 5-bit swallow counter used in the programmable feedback divider. The RF\_A control word can be programmed to values ranging from 0 to 31.

Divide Ratio	LMX2434 RF_A[4:0]				
	4	3	2	1	0
0	0	0	0	0	0
1	0	0	0	0	1
•	•	•	•	•	•
31	1	1	1	1	1

### 2.5.2 LMX243x RF Synthesizer Programmable Binary Counter

#### 2.5.2.1 RF\_B[14:0] - LMX2430/33 RF Synthesizer Programmable Binary Counter (B Counter) (R1[21:7])

The RF\_B control word is used to setup the RF synthesizer's B counter. For both the LMX2430 and LMX2433, the B counter is a 15-bit programmable binary counter used in the programmable feedback divider. The RF\_B control word can be programmed to values ranging from 3 to 32767. Divide ratios less than 3 are prohibited.

Divide Ratio	LMX2430/33 RF_B[14:0]														
	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

#### 2.5.2.2 RF\_B[13:0] - LMX2434 RF Synthesizer Programmable Binary Counter (B Counter) (R1[21:8])

The LMX2434 B counter is a 14-bit programmable binary counter used in the programmable feedback divider. The RF\_B control word can be programmed to values ranging from 3 to 16383. Divide ratios less than 3 are prohibited.

Divide Ratio	LMX2434 RF_B[13:0]													
	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
16383	1	1	1	1	1	1	1	1	1	1	1	1	1	1

### 2.5.3 LMX243x RF Synthesizer Prescaler Select

#### 2.5.3.1 RF\_P - LMX2430/33 RF Synthesizer Prescaler Select (R1[22])

Both the LMX2430 and LMX2433 RF synthesizers utilize a selectable dual modulus prescaler. An 8/9 or a 16/17 prescale ratio can be selected.

Control Bit	Register Location	Description	Function	
			0	1
RF_P	R1[22]	LMX2430/33 RF Prescaler Select	8/9 Prescaler Selected	16/17 Prescaler Selected

#### 2.5.3.2 RF\_P - LMX2434 RF Synthesizer Prescaler Select (R1[22])

The LMX2434 RF synthesizer utilizes a selectable dual modulus prescaler. A 16/17 or a 32/33 prescale ratio can be selected.

Control Bit	Register Location	Description	Function	
			0	1
RF_P	R1[22]	LMX2434 RF Prescaler Select	16/17 Prescaler Selected	32/33 Prescaler Selected

## 2.0 Programming Description (Continued)

### 2.5.4 RF\_PD - RF Synthesizer Powerdown (R1[23])

The RF\_PD bit is used to switch the RF PLL between a powered up and powered down mode.

Furthermore, the RF\_PD bit operates in conjunction with the RF\_CPT bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.4.4** for more details on how to program the RF\_CPT bit.

Control Bit	Register Location	Description	Function	
			0	1
RF_PD	R1[23]	RF Powerdown	RF PLL Active	RF PLL Powerdown

### 2.6 R2 REGISTER

The R2 Register contains the RF\_TOC control word. The RF\_TOC is used to setup the RF synthesizer's Fastlock circuitry. The RF\_TOC is a 12-bit binary counter programmable from 0 to 4095.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD		
R2	0	0	0	0	0	0	0	0	0	RF_TOC[11:0]											0	1	0	

#### 2.6.1 RF\_TOC[0:11] - RF Synthesizer Timeout Counter (R2[14:3])

The FLoutRF pin can be configured as a general purpose CMOS TRI-STATE output or as a Fastlock output by programming the RF\_TOC appropriately. When the RF\_TOC is programmed from 0 to 3, Automatic Fastlock is disabled, and the FLoutRF pin is either configured as a general purpose CMOS TRI-STATE output or Manual Fastlock is enabled. When the RF\_TOC is programmed to 0, the FLoutRF pin will be in TRI-STATE (high impedance) mode. The charge pump current is then the value specified by RF\_CPG (R0[19]). When the RF\_TOC is programmed to 1, the FLoutRF pin is pulled to a LOW state. The charge pump current is then set to a HIGH gain state (RF\_CPG bit = 1). This condition is known as the Manual Fastlock. When the RF\_TOC is programmed to 2, the FLout\_RF pin will again be pulled to a LOW state, but this time the charge pump current is the value specified by RF\_CPG (R0[19]). When the RF\_TOC is programmed to 3, the FLoutRF pin is pulled to a HIGH state. Again, the charge pump current is the value specified by RF\_CPG (R0[19]). When the RF\_TOC is programmed from 4 to 4095, Fastlock is enabled and the FLoutRF pin is pulled to a LOW state. Fastlock will time-out after the specified number of PFD events. At this time, the FLoutRF pin will switch to TRI-STATE (high impedance) mode. The value programmed into RF\_TOC represents the number of PFD events that the RF synthesizer will spend in the Fastlock state. Note that any write to the RF\_TOC requires a PFD event on the RF synthesizer to latch the contents. This means that writes to the RF\_TOC take effect synchronously with the next PFD event.

RF_TOC[11:0]	FastLock Mode	Fastlock Period [PFD Events]	FLoutRF Pin Functionality/ State	I <sub>CPoutRF</sub> Magnitude
0	Disabled	N/A	General Purpose. High Impedance State	I <sub>CPoutRF</sub> magnitude controlled by R0[19]
1	Enabled Manual Fastlock	N/A	General Purpose. Logic LOW State	I <sub>CPoutRF</sub> = 4 mA
2	Disabled	N/A	General Purpose. Logic LOW State	I <sub>CPoutRF</sub> magnitude controlled by R0[19]
3	Disabled	N/A	General Purpose. Logic HIGH State	I <sub>CPoutRF</sub> magnitude controlled by R0[19]
4	Enabled Automatic Fastlock	4	FastLock. Logic LOW State. Switches to High Impedance after 4 PFD events	I <sub>CPoutRF</sub> = 4 mA Switches to 1 mA after 4 PFD events
...	...	...	...	...
4095	Enabled Automatic Fastlock	4095	FastLock. Logic LOW State. Switches to High Impedance after 4095 PFD events	I <sub>CPoutRF</sub> = 4 mA Switches to 1 mA after 4095 PFD events

## 2.0 Programming Description (Continued)

### 2.7 R3 REGISTER

The R3 register contains the IF\_R, IF\_CPP, IF\_CPG, IF\_CPT, and IF\_RST control words, in addition to two of the four bits that compose the MUX control word. The detailed descriptions and programming information for each control word is discussed in the following sections.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD			
R3	MUX[1:0]		IF_RST	IF_CPT	IF_CPG	IF_CPP	IF_R[14:0]																0	1	1

#### 2.7.1 IF\_R[14:0] - IF Synthesizer Programmable Reference Divider (R Counter) (R3[17:3])

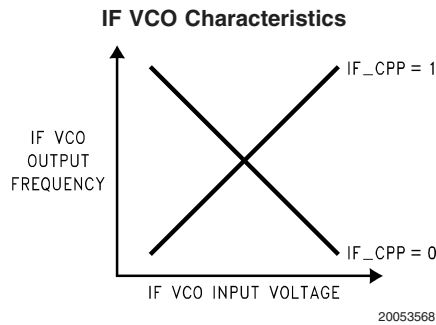
The IF reference divider (IF\_R) can be programmed to support divide ratios from 3 to 32767. Divide ratios less than 3 are prohibited.

Divide Ratio	IF_R[14:0]														
	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
32767	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

#### 2.7.2 IF\_CPP - IF Synthesizer Phase Detector Polarity (R3[18])

The IF\_CPP bit is used to control the IF synthesizer's phase/ frequency detector polarity based on the VCO tuning characteristics.

Control Bit	Register Location	Description	Function	
			0	1
IF_CPP	R3[18]	IF Phase/ Frequency Detector Polarity	IF VCO Negative Tuning Characteristics	IF VCO Positive Tuning Characteristics



## 2.0 Programming Description (Continued)

### 2.7.3 IF\_CPG - IF Synthesizer Charge Pump Current Gain (R3[19])

The IF\_CPG bit controls the IF synthesizer's charge pump gain. Two gain levels are available.

Control Bit	Register Location	Description	Function	
			0	1
IF_CPG	R3[19]	IF Charge Pump Current Gain	LOW 1 mA	HIGH 4 mA

### 2.7.4 IF\_CPT - IF Synthesizer Charge Pump TRI-STATE (R3[20])

The IF\_CPT bit allows the charge pump to be switched between a normal operating mode and a high impedance output state. This happens asynchronously with the change in the IF\_CPT bit.

Furthermore, the IF\_CPT bit operates in conjunction with the IF\_PD bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.8.4** for more details on how to program the IF\_PD bit.

Control Bit	Register Location	Description	Function	
			0	1
IF_CPT	R3[20]	IF Charge Pump TRI-STATE	IF Charge Pump Normal Operation	IF Charge Pump Output in High Impedance State

### 2.7.5 IF\_RST - IF Synthesizer Counter Reset (R3[21])

The IF\_RST bit resets of the IF\_A, IF\_B and IF\_R counters. After removing the reset, the IF\_A and IF\_B counters resume counting in close alignment with the IF\_R counter. The maximum error is one prescaler cycle.

Control Bit	Register Location	Description	Function	
			0	1
IF_RST	R3[21]	IF Counter Reset	IF_A, IF_B and IF_R Normal Operation	IF_A, IF_B and IF_R Reset

## 2.8 R4 REGISTER

The R4 register contains the IF\_A, IF\_B, IF\_P, and IF\_PD control words. The IF\_A and IF\_B control words are used to setup the programmable feedback divider. The detailed descriptions and programming information for each control word is discussed in the following sections. R4[21] is always set to 0.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0		
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD				
R4	IF_PD	IF_P	0	IF_B[13:0]																	IF_A[3:0]			1	0	0

### 2.8.1 IF\_A[3:0] - IF Synthesizer Swallow Counter (A Counter) (R4[6:3])

The IF\_A control word is used to setup the IF synthesizer's A counter. The A counter is a 4-bit swallow counter used in the programmable feedback divider. The IF\_A control word can be programmed to values ranging from 0 to 15.

Divide Ratio	IF_A[3:0]			
	3	2	1	0
0	0	0	0	0
1	0	0	0	1
•	•	•	•	•
15	1	1	1	1

## 2.0 Programming Description (Continued)

### 2.8.2 IF\_B[13:0] - IF Synthesizer Programmable Binary Counter (B Counter) (R4[20:7])

The IF\_B control word is used to setup the IF synthesizer's B counter. The B counter is a 14-bit programmable binary counter used in the programmable feedback divider. The IF\_B control word can be programmed to values ranging from 3 to 16383. Divide ratios less than 3 are prohibited.

Divide Ratio	IF_B[13:0]													
	13	12	11	10	9	8	7	6	5	4	3	2	1	0
3	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
16383	1	1	1	1	1	1	1	1	1	1	1	1	1	1

### 2.8.3 IF\_P - IF Synthesizer Prescaler Select (R4[22])

The LMX243x IF synthesizer utilizes a selectable dual modulus prescaler. An 8/9 or a 16/17 prescale ratio can be selected.

Control Bit	Register Location	Description	Function	
			0	1
IF_P	R4[22]	IF Prescaler Select	8/9 Prescaler Selected	16/17 Prescaler Selected

### 2.8.4 IF\_PD - IF Synthesizer Powerdown (R4[23])

The IF\_PD bit is used to switch the IF PLL between a powered up and powered down mode.

Furthermore, the IF\_PD bit operates in conjunction with the IF\_CPT bit to set a synchronous or an asynchronous powerdown mode. Refer to **Section 2.7.4** for more details on how to program the IF\_CPT bit.

Control Bit	Register Location	Description	Function	
			0	1
IF_PD	R4[23]	IF Powerdown	IF PLL Active	IF PLL Powerdown

## 2.0 Programming Description (Continued)

### 2.9 R5 REGISTER

The R5 Register contains the IF\_TOC control word. The IF\_TOC is used to setup the IF synthesizer's Fastlock circuitry. The IF\_TOC is a 12-bit binary counter programmable from 0 to 4095.

Reg	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	DATA[20:0] FIELD																					ADDRESS [2:0] FIELD		
R5	0	0	0	0	0	0	0	0	0	IF_TOC[11:0]											1	0	1	

#### 2.9.1 IF\_TOC[0:11] - IF Synthesizer Timeout Counter (R5[14:3])

The OSCout/ FLoutIF pin can be configured as a general purpose CMOS TRI-STATE output or as a Fastlock output by programming the IF\_TOC appropriately. When the IF\_TOC is programmed from 0 to 3, Automatic Fastlock is disabled, and the OSCout/ FLoutIF pin is configured as a general purpose CMOS TRI-STATE output or Manual Fastlock is enabled. When the IF\_TOC is programmed to 0, the OSCout/ FLoutIF pin will be in TRI-STATE (high impedance) mode. The charge pump current is then the value specified by IF\_CPG (R3[19]). When the IF\_TOC is programmed to 1, the OSCout/ FLoutIF pin is pulled to a LOW state. The charge pump current is then set to a HIGH gain state (IF\_CPG bit = 1). This condition is known as the Manual Fastlock. When the IF\_TOC is programmed to 2, the OSCout/ FLout\_IF pin will again be pulled to a LOW state, but this time the charge pump current is the value specified by IF\_CPG (R3[19]). When the IF\_TOC is programmed to 3, the OSCout/ FLoutIF pin is pulled to a HIGH state. Again, the charge pump current is the value specified by IF\_CPG (R3[19]). When the IF\_TOC is programmed from 4 to 4095, Fastlock is enabled and the OSCout/ FLoutIF pin is pulled to a LOW state. Fastlock will time-out after the specified number of PFD events. At this time, the OSCout/ FLoutIF pin will switch to TRI-STATE (high impedance) mode. The value programmed into IF\_TOC represents the number of PFD events that the IF synthesizer will spend in the Fastlock state. Note that any write to the IF\_TOC requires a PFD event on the IF synthesizer to latch the contents. This means that writes to the IF\_TOC take effect synchronously with the next PFD event.

IF_TOC[11:0]	FastLock Mode	Fastlock Period [PFD Events]	OSCout/ FLoutIF Pin Functionality/ State	I <sub>CPoutIF</sub> Magnitude
0	Disabled	N/A	General Purpose. High Impedance State	I <sub>CPoutIF</sub> magnitude controlled by R3[19]
1	Enabled Manual Fastlock	N/A	General Purpose. Logic LOW State	I <sub>CPoutIF</sub> = 4 mA
2	Disabled	N/A	General Purpose. Logic LOW State	I <sub>CPoutIF</sub> magnitude controlled by R3[19]
3	Disabled	N/A	General Purpose. Logic HIGH State	I <sub>CPoutIF</sub> magnitude controlled by R3[19]
4	Enabled Automatic Fastlock	4	FastLock. Logic LOW State. Switches to High Impedance after 4 PFD events	I <sub>CPoutIF</sub> = 4 mA Switches to 1 mA after 4 PFD events
...	...	...	...	...
4095	Enabled Automatic Fastlock	4095	FastLock. Logic LOW State. Switches to High Impedance after 4095 PFD events	I <sub>CPoutIF</sub> = 4 mA Switches to 1 mA after 4095 PFD events

## 2.0 Programming Description (Continued)

### 2.10 MUX[3:0] - MULTIFUNCTION OUTPUT SELECT (R3[23:22]:R0[23:22])

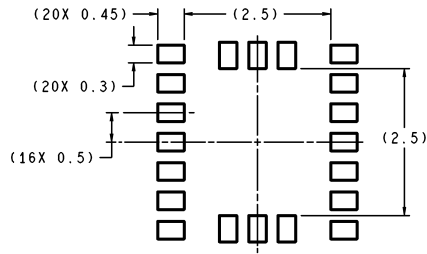
The MUX control word is used to determine which signal is routed to the Ftest/LD pin.

MUX[3:0]				MUX Output State
0	0	0	0	High Impedance (TRI-STATE) State Output
0	0	0	1	Logic HIGH State Output
0	0	1	0	Logic LOW State Output
0	0	1	1	RF PLL and IF PLL Digital Lock Detect. Open Drain Output
0	1	0	0	RF PLL Digital Lock Detect. Open Drain Output
0	1	0	1	IF PLL Digital Lock Detect. Open Drain Output
0	1	1	0	RF PLL and IF PLL Analog Lock Detect. Open Drain Output
0	1	1	1	RF PLL Analog Lock Detect. Open Drain Output
1	0	0	0	IF PLL Analog Lock Detect. Open Drain Output
1	0	0	1	RF PLL and IF PLL Analog Lock Detect. Push-Pull Output
1	0	1	0	RF PLL Analog Lock Detect. Push-Pull Output
1	0	1	1	IF PLL Analog Lock Detect. Push-Pull Output
1	1	0	0	IF_R/ 2 Frequency
1	1	0	1	IF_N/ 2 Frequency
1	1	1	0	RF_R/ 2 Frequency
1	1	1	1	RF_N/ 2 Frequency

**Notes:**

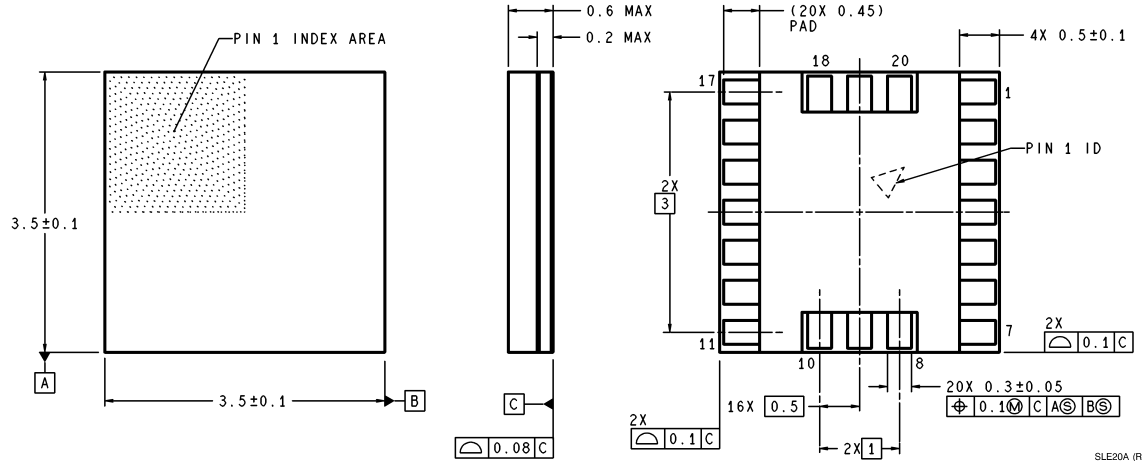
1.  $RF\_N = (RF\_B * RF\_P) + RF\_A$
2.  $IF\_N = (IF\_B * IF\_P) + IF\_A$

**Physical Dimensions** inches (millimeters) unless otherwise noted



RECOMMENDED LAND PATTERN  
1:1 RATIO WITH PACKAGE SOLDER PADS

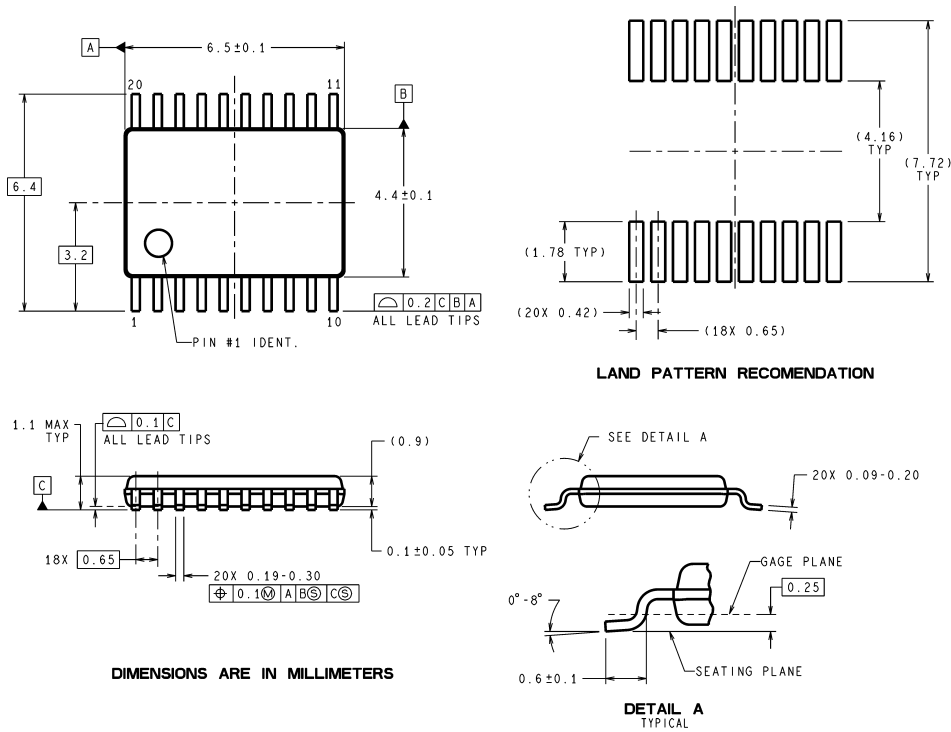
DIMENSIONS ARE IN MILLIMETERS



**20-Pin Ultra Thin Chip Scale Package (UTCSP)**  
**NS Package Number SLE20A**

SLE20A (Rev A)

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



DIMENSIONS ARE IN MILLIMETERS

MTC20 (Rev E)

**20-Pin Thin Shrink Small Outline Package (TSSOP)  
NS Package Number MTC20**

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